

**3V 32M-BIT**

**SERIAL NOR FLASH WITH  
DUAL AND QUAD SPI&QPI**

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## FEATURES

### ■ Low power supply operation

- Single 2.7V-3.6V supply

### ■ 32 Mbit Serial Flash

- 32 M-bit/4M-byte/16,384 pages
- 256 bytes per programmable page
- Uniform 4K-byte Sectors, 32K/64K-byte Blocks

### ■ New Family of SpiFlash Memories

- Standard SPI: CLK, CS#, DI, DO, WP#, HOLD# / RESET#
- Dual SPI: CLK, CS#, DI, DO, WP#, HOLD# / RESET#
- Quad SPI: CLK, CS#, IO0, IO1, IO2, IO3
- QPI: CLK, CS#, IO0, IO1, IO2, IO3
- Software & Hardware Reset
- Auto-increment Read capability

### ■ Temperature Ranges

- Consumer (-20°C to +85°C)
- Industrial (-40°C to +85°C)

### ■ Low power consumption

- 9 mA typical active current
- 2 uA typical power down current

### ■ Efficient “Continuous Read” and QPI Mode

- Continuous Read with 8/16/32/64-Byte Wrap
- As few as 8 clocks to address memory
- Quad Peripheral Interface(QPI) reduces instruction overhead

### ■ Flexible Architecture with 4KB sectors

- Sector Erase (4K-bytes)
- Block Erase (32K/64K-bytes)
- Page Program up to 256 bytes
- Typical 100K erase/program cycles
- More than 20-year data retention

### ■ Advanced Security Feature

- Software and Hardware Write-Protect
- Power Supply Lock-Down and OTP protection
- Top/Bottom, Complement array protection
- 64-Bit Unique ID for each device
- Discoverable parameters(SFDP) register
- 3X256-Bytes Security Registers with OTP locks
- Volatile & Non-volatile Status Register Bits

### ■ High performance program/erase speed

- Page program time: 500us typical
- Sector erase time: 50ms typical
- Block erase time: 300ms typical
- Chip erase time: 10 Seconds typical

### ■ Package Options

- SOP 208mil 8L
- SOP 150mil 8L
- WSON 5x6 8L
- All Pb-free packages are RoHS compliant

## GENERAL DESCRIPTION

The XM25QH32B of non-volatile flash memory device supports the standard Serial Peripheral Interface (SPI). Traditional SPI single bit serial input and output (Single I/O or SIO) is supported as well as optional two bit (Dual I/O or DIO) and four bit (quad I/O or QIO) serial protocols. This multiple width interface is called SPI Multi-I/O or MIO.

The SPI protocols use only 4 to 6 signals:

- ◆ Chip Select (CS#)
- ◆ Serial Clock (CLK)
- ◆ Serial Data
  - IO0 (DI)
  - IO1 (DO)
  - IO2 (WP#)
  - IO3 (HOLD# / RESET#)

The XM25QH32B support the standard Serial Peripheral Interface (SPI), Dual/Quad I/O SPI as well as 2-clocks instruction cycle Quad Peripheral Interface (QPI): Serial Clock, Chip Select, Serial Data I/O0 (DI), I/O1 (DO), I/O2 (WP#), and I/O3 (HOLD# / RESET#). SPI clock frequencies of up to 104MHz are supported allowing equivalent clock rates of 208MHz (104MHz x 2) for Dual I/O and 416MHz (104MHz x 4) for Quad I/O when using the Fast Read Dual/Quad I/O and QPI instructions. These transfer rates can outperform standard Asynchronous 8 and 16-bit Parallel Flash memories. The Continuous Read Mode allows for efficient memory access with as few as 8-clocks of instruction-overhead to read a 24-bit address, allowing true XIP (execute in place) operation.

A Hold pin, Write Protect pin and programmable write protection, with top or bottom array control, provide further control flexibility. Additionally, the device supports JEDEC standard manufacturer and device ID and SFDP Register, a 64-bit Unique Serial Number and three 256-bytes Security Registers.

The XM25QH32B provides an ideal storage solution for systems with limited space, signal connections, and power. These memories' flexibility and performance is better than ordinary serial flash devices. They are ideal for code shadowing to RAM, executing code directly (XIP), and storing reprogrammable data.

## 1. ORDERING INFORMATION

The ordering part number is formed by a valid combination of the following:

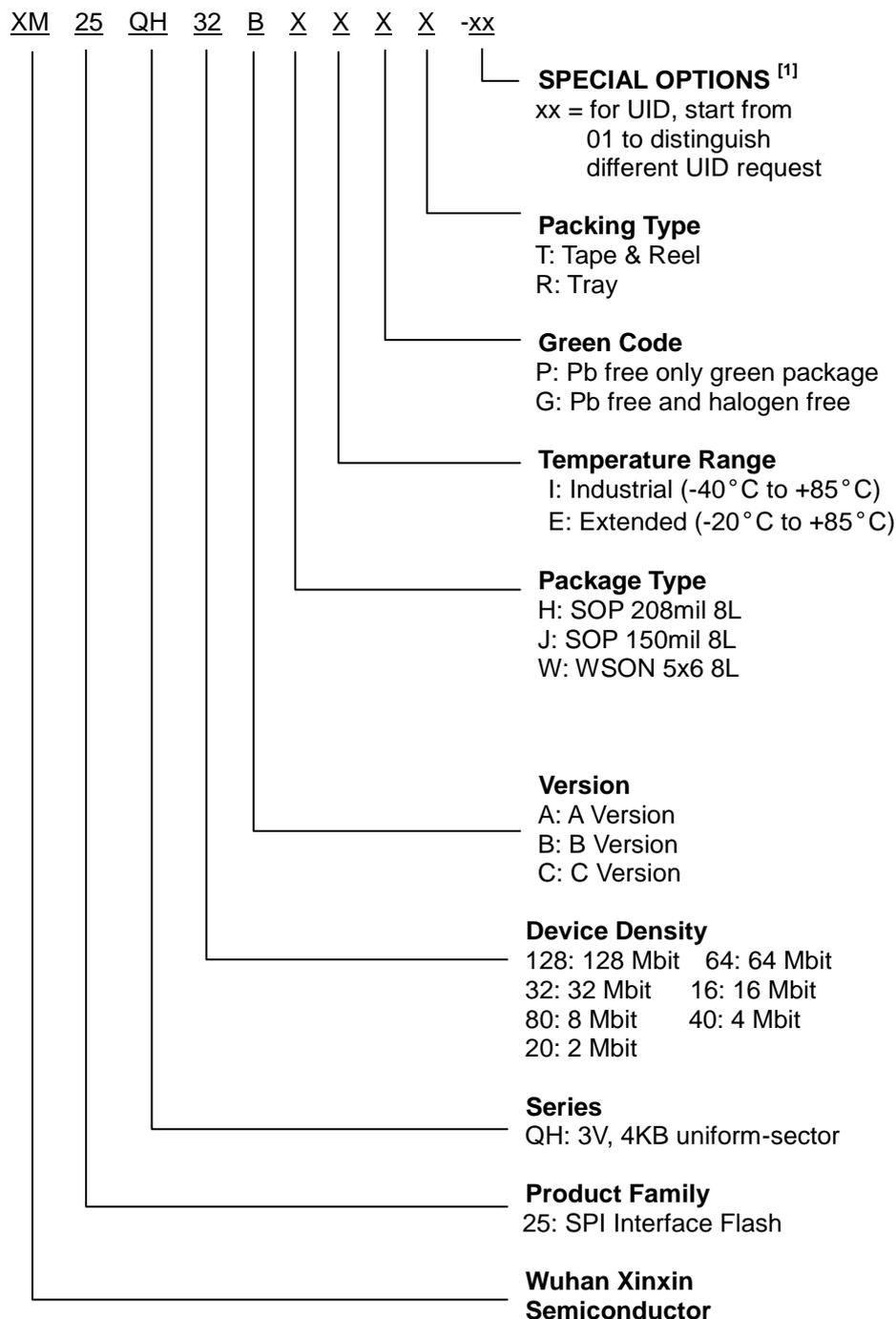


Figure 1.1 Ordering Information

**Notes:**

- 1、 This option code is not included on the part marketing.

## 2. BLOCK DIAGRAM

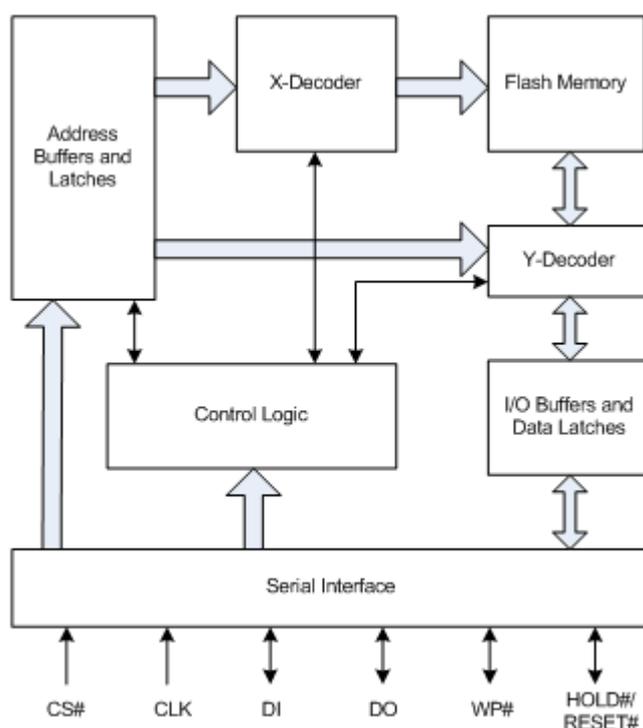


Figure 2.1 Block Diagram

### 3. CONNECTION DIAGRAMS

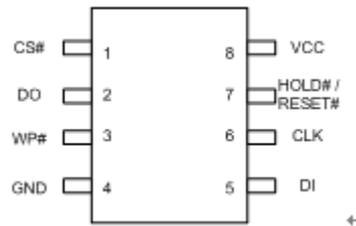


Figure 3.1 8-pin SOP (150/208mil)

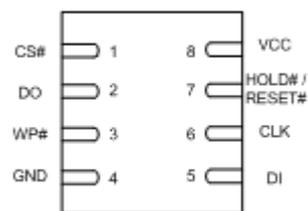


Figure 3.2 8-Contact 5 x 6 mm WSON

## 4. SIGNAL DESCRIPTIONS

Table 4.1 Pin Descriptions

Symbol	Pin Name
CLK	Serial Clock Input
DI(IO0)	Serial Data Input(Data input output 0) <sup>(1)</sup>
DO(IO1)	Serial Data Output(Data input output 1) <sup>(1)</sup>
CS#	Chip Enable
WP#(IO2) <sup>(3)</sup>	Write Protect (Data input output 2) <sup>(2)</sup>
HOLD# / RESET# <sup>(3)</sup> (IO3)	Hold or Reset input(Data input output 3) <sup>(2)</sup>
V <sub>cc</sub>	Power Supply (2.7-3.6V)
GND	Ground

**Notes:**

(1) IO0 and IO1 are used for Standard and Dual SPI instructions.

(2) IO0—IO3 are used for QUAD SPI / QPI instructions.

(3) WP# and HOLD# / RESET# functions are only available for Standard and Dual SPI.

### 4.1. Serial Data Input (DI) / IO0

The SPI Serial Data Input (DI) pin is used to transfer data serially into the device. It receives instructions, address and data to be programmed. Data is latched on the rising edge of the Serial Clock (CLK) input pin. The DI pin becomes IO0 - an input and output during Dual and Quad commands for receiving instructions, address, and data to be programmed (values latched on rising edge of serial CLK clock signal) as well as shifting out data (on the falling edge of CLK).

### 4.2. Serial Data Output (DO) / IO1

The SPI Serial Data Output (DO) pin is used to transfer data serially out of the device. Data is shifted out on the falling edge of the Serial Clock (CLK) input pin. DO becomes IO1 - an input and output during Dual and Quad commands for receiving instructions, addresses, and data to be programmed (values latched on rising edge of serial CLK clock signal) as well as shifting out data (on the falling edge of CLK).

### 4.3. Serial Clock (CLK)

The SPI Serial Clock Input (CLK) pin provides the timing for serial input and output operations. ("See SPI Mode")

### 4.4. Chip Select (CS#)

The SPI Chip Select (CS#) pin enables and disables device operation. When CS# is high the device is deselected and the Serial Data Output pins are at high impedance.

When deselected, the devices power consumption will be at standby levels unless an internal erase, program or status register cycle is in progress. When CS# is brought low the device will be selected, power consumption will increase to active levels and instructions can be written to and data read from the device. After power-up, CS# must transition from high to low before a new instruction will be accepted.

#### 4.5. Write Protect (WP#) / IO2

The Write Protect (WP#) pin can be used to prevent the Status Register from being written. Used in conjunction with the Status Register's Block Protect (BP0, BP1 and BP2, TB, SEC, CMP) bits and Status Register Protect (SRP0) bits, a portion or the entire memory array can be hardware protected.

The WP# function is not available when the Quad mode is enabled. The WP# function is replaced by IO2 for input and output during Quad mode for receiving addresses and data to be programmed (values are latched on rising edge of the CLK signal) as well as shifting out data (on the falling edge of CLK).

#### 4.6. HOLD (HOLD#) / IO3

The HOLD# pin allows the device to be paused while it is actively selected. When HRSW bit is '0' (factory default is '0'), the HOLD# pin is enabled. When HOLD# is brought low, while CS# is low, the DO pin will be at high impedance and signals on the DI and CLK pins will be ignored (don't care). When HOLD# is brought high, device operation can resume. The HOLD# function can be useful when multiple devices are sharing the same SPI signals. The HOLD# pin is active low. When the QE bit of Status Register-2 is set for Quad I/O, the HOLD# pin function is not available since this pin is used for IO3.

#### 4.7. RESET (RESET#) / IO3

The RESET# pin allows the device to be reset by the controller. When HRSW bit is '1' (factory default is '0'), the RESET# pin is enabled. Drive RESET# low for a minimum period of ~1us (tRESET\*) will interrupt any on-going external/internal operations, regardless the status of other SPI signals (CS#, CLK, DI, DO, WP# and/or HOLD#). The Hardware Reset function is only available for standard SPI and Dual SPI operation, when QE=0, the IO3 pin can be configured either as a HOLD# pin or as a RESET# pin depending on Status Register setting, when QE=1, this pin is the Serial Data IO (IO3) for Quad I/O operation.

## 5. MEMORY ORGANIZATION

### 5.1. Flash Memory Array

The memory is organized as:

- 4,194,304bytes
- Uniform Sector Architecture 64 blocks of 64-Kbyte
- 1024 sectors of 4-Kbyte
- 16, 384 pages (256 bytes each)

Each page can be individually programmed (bits are programmed from 1 to 0). The device is Sector, Block or Chip Erasable but not Page Erasable.

Table 5.1<sup>(1)</sup> Memory Organization

Block/ Security Register/SFDP	Sector	Address range	
Security Register 3	-	003000H	0030FFH
Security Register 2	-	002000H	0020FFH
Security Register 1	-	001000H	0010FFH
Security Register 0 (SFDP)	-	000000H	0000FFH
Block 63	1023	3FF000H	3FFFFFFH
	.....	.....	.....
Block 62	1008	3F0000H	3F0FFFH
	1007	3EF000H	3EFFFFH
.....	.....	.....	.....
	992	3E0000H	3E0FFFH
.....	.....	.....	.....
	.....	.....	.....
.....	.....	.....	.....
	.....	.....	.....
Block 2	47	02F000H	02FFFFH
	.....	.....	.....
Block 1	32	020000H	020FFFH
	31	01F000H	01FFFFH
.....	.....	.....	.....
	16	010000H	010FFFH
Block 0	15	00F000H	00FFFFH
	.....	.....	.....
.....	0	000000H	000FFFH
	.....	.....	.....

**Notes:**

(1) These are condensed tables that use a couple of sectors as references. There are address ranges that are not explicitly listed. All 4-kB sectors have the pattern XXX000h-XXXXFFh.

### 5.2. Security Registers

The XM25QH32B provides four 256-byte Security Registers. Each register can be used to store information that can be permanently protected by programming One Time Programmable (OTP) lock bits in Status Register-2.

Register 0 is used by XMC to store and protect the Serial Flash Discoverable Parameters (SFDP) information that is also accessed by the Read SFDP command. See Table 5.1.

The three additional Security Registers can be erased, programmed, and protected individually. These registers may be used by system manufacturers to store and permanently protect security or other important information separate from the main memory array.

### 5.2.1 Security Register 0

#### Serial Flash Discoverable Parameters (SFDP — JEDEC ):

This document defines the Serial Flash Discoverable Parameters (SFDP) revision B data structure for XM25QH32B family. These data structure values are an update to the earlier revision SFDP data structure in the XM25QH32B family devices.

The Read SFDP (RSFDP) command (5Ah) reads information from a separate flash memory address space for device identification, feature, and configuration information, in accord with the JEDEC standard for Serial Flash Discoverable Parameters.

The SFDP data structure consists of a header table that identifies the revision of the JESD216 header format that is supported and provides a revision number and pointer for each of the SFDP parameter tables that are provided. The parameter tables follow the SFDP header. However, the parameter tables may be placed in any physical location and order within the SFDP address space. The tables are not necessarily adjacent nor in the same order as their header table entries.

The SFDP header points to the following parameter tables:

- Basic Flash
  - This is the original SFDP table.

The physical order of the tables in the SFDP address space is: SFDP Header, and Basic Flash. The SFDP address space is programmed by XMC and read-only for the host system.

### 5.2.2 Serial Flash Discoverable Parameters (SFDP) Address Map

The SFDP address space has a header starting at address zero that identifies the SFDP data structure and provides a pointer to each parameter. One Basic Flash parameter is mandated by the JEDEC standard.

Table 5.2 SFDP Overview Map — Security Register 0

Byte Address	Description
0000h	Location zero within JEDEC SFDP space – start of SFDP header
...	Remainder of SFDP header followed by undefined space
0030h	Start of SFDP parameter
...	Remainder of SFDP JEDEC parameter followed by undefined space
006Fh	End of SFDP space
0070h to 00FFh	Reserved space

**5.2.3 SFDP Header Field Definitions**

Table 5.3 SFDP Header (Sheet 1 of 1)

Description	Add (h) (Byte)	DW Add (Bit)	Data	Comment
<b>SFDP Signature</b>	00h	07 : 00	53h	Fixed: 50444653h
	01h	15 : 08	46h	
	02h	23 : 16	44h	
	03h	31 : 24	50h	
<b>SFDP Minor Revision Number</b>	04h	07 : 00	00h	Star from 0x00
<b>SFDP Major Revision Number</b>	05h	15 : 08	01h	Star from 0x01
<b>Number of Parameter Headers (NPH)</b>	06h	23 : 16	01h	This number is 0-based. Therefore, 0 indicates 1 parameter header.
<b>Unused</b>	07h	31 : 24	FFh	Reserved
<b>ID Number(JEDEC)</b>	08h	07 : 00	00h	00h:it indicates a JEDEC specified header.
<b>Parameter Table Minor Revision Number</b>	09h	15 : 08	00h	Star from 0x00
<b>Parameter Table Major Revision Number</b>	0Ah	23 : 16	01h	Star from 0x01
<b>Parameter Table Length (in double word)</b>	0Bh	31 : 24	09h	How many DWORDs in the parameter table
<b>Parameter Table Pointer (PTP)</b>	0Ch	07 : 00	30h	First address of JEDEC Flash Parameter table
	0Dh	15 : 08	00h	
	0Eh	23 : 16	00h	
<b>Unused</b>	0Fh	31 : 24	FFh	
<b>ID number(Manufacturer ID)</b>	10h	07 : 00	20h	It indicates manufacture ID
<b>Parameter Table Minor Revision Number</b>	11h	15 : 08	00h	Start from 00h
<b>Parameter Table Major Revision Number</b>	12h	23 : 16	01h	Start from 01h
<b>Parameter Table Length(in double word)</b>	13h	31 : 24	04h	How many DWORDs in the parameter table
<b>Parameter Table Pointer(PTP)</b>	14h	07 : 00	60h	First address of VENDOR Flash Parameter table
	15h	15 : 08	00h	
	16h	23 : 16	00h	
<b>Unused</b>	17h	31 : 24	FFh	

**5.2.4 JEDEC SFDP Basic SPI Flash Parameter**

Table 5.4 Basic SPI Flash Parameter, JEDEC Flash Parameter Tables (Sheet 1 of 9)

Description	Add (h) (Byte)	DW Add (Bit)	Data	Comment
<b>Block / Sector Erase sizes</b>	30h	01 : 00	01b	00:Reserved, 01:4KB erase, 10:Reserved, 11:not supported 4KB erase
<b>Write Granularity</b>		02	1b	0:1Byte,1:64Byte or larger
<b>Volatile Status Register Block Protect bits</b>		03	0b	0: Block Protect bits in device's status register are solely non-volatile or may be programmed either as volatile using the 50h instruction for write enable or non-volatile using the 06h instruction for write enable. 1: Block Protect bits in device's status register are solely volatile.
<b>Write Enable Instruction Select for Writing to Volatile Status Registers</b>		04	0b	0:use 50h instruction 1:use 06h instruction
<b>Unused</b>		07 : 05	111b	Contains 111b and can never be changed
<b>4KB Erase Instruction</b>	31h	15 : 08	20h	
<b>(1-1-2) Fast Read<sup>(1)</sup></b>	32h	16	1b	0 = not supported 1 = supported
<b>Address Bytes Number used in addressing flash array</b>		18 : 17	00b	00:3Byte only, 01:3 or 4Byte 10:4Byte only, 11:Reserved
<b>Double Transfer Rate(DTR) clocking</b>		19	0b	0 = not supported 1 = supported
<b>(1-2-2) Fast Read</b>		20	1b	0 = not supported 1 = supported
<b>(1-4-4) Fast Read</b>		21	1b	0 = not supported 1 = supported
<b>(1-1-4) Fast Read</b>		22	1b	0 = not supported 1 = supported
<b>Unused</b>		23	1b	
<b>Unused</b>		33h	31 : 24	FFh

Table 5.4 Basic SPI Flash Parameter, JEDEC Flash Parameter Tables (Sheet 2 of 9)

Description	Add (h) (Byte)	DW Add (Bit)	Data	Comment
<b>Flash Memory Density</b>	37h : 34h	31 : 00	01FFFFFFh	For densities 2 gigabits or less, bit-31 is set to 0b. The field 30:0 defines the size in bits. Example: 00FFFFFFh = 16 megabits For densities 4 gigabits and above, bit-31 is set to 1b. The field 30:0 defines 'N' where the density is computed as 2^N bits (N must be >= 32). Example: 80000021h = 2^33 = 8 gigabits

Table 5.4 Basic SPI Flash Parameter, JEDEC Flash Parameter Tables (Sheet 3 of 9)

Description	Add (h) (Byte)	DW Add (Bit)	Data	Comment
(1-4-4)Fast Read number of Wait states <sup>(2)</sup>	38h	04 : 00	00100b	00000b:Not supported;00100b:4 00110b:6 01000b:8
(1-4-4)Fast Read number of Mode Clocks <sup>(3)</sup>		07 : 05	010b	Mode clocks: 000b:Not supported;010: 2 clocks
(1-4-4)Fast Read instruction	39h	15 : 08	EBh	
(1-1-4)Fast Read Number of Wait states	3Ah	20 : 16	01000b	00000b:Not supported;00100b:4 00100b:6; 01000b:8
(1-1-4)Fast Read Number of Mode Clocks		23 : 21	000b	Mode clocks: 000b:Not supported;010b:2 clocks
(1-1-4)Fast Read Instruction	3Bh	31 : 24	6Bh	

Table 5.4 Basic SPI Flash Parameter, JEDEC Flash Parameter Tables (Sheet 4 of 9)

Description	Add (h) (Byte)	DW Add (Bit)	Data	Comment
(1-1-2)Fast Read Number of Wait states	3Ch	04 : 00	01000b	00000b:Not supported;00100b:4 00110b:6;01000b:8
(1-1-2)Fast Read Number of Mode Clocks		07 : 05	000b	Mode clocks: 000b:Not supported;010:2 clocks
(1-1-2)Fast Read Instruction	3Dh	15 : 08	3Bh	
(1-2-2)Fast Read Number of Wait states	3Eh	20 : 16	00100b	00000b:Not supported; 00010b:2; 00100b:4;00110b:6;01000b:8
(1-2-2)Fast Read Number of Mode Clocks		23 : 21	000b	Mode clocks: 000b:Not supported;010:2 clocks; 100:4 clocks
(1-2-2)Fast Read Instruction	3Fh	31 : 24	BBh	

Table 5.4 Basic SPI Flash Parameter, JEDEC Flash Parameter Tables (Sheet 5 of 9)

Description	Add (h) (Byte)	DW Add (Bit)	Data	Comment
(2-2-2)Fast Read	40h	00	0b	0 = not supported 1 = supported
Unused		03 : 01	111b	
(4-4-4)Fast Read		04	1b	0 = not supported 1 = supported
Unused		07 : 05	111b	
Unused	43h : 41h	31 : 08	FFFFFFh	

Table 5.4 Basic SPI Flash Parameter, JEDEC Flash Parameter Tables (Sheet 6 of 9)

Description	Add (h) (Byte)	DW Add (Bit)	Data	Comment
Unused	45h : 44h	15 : 00	FFh	
(2-2-2)Fast Read Number of Wait states	46h	20 : 16	00000b	00000b:Not supported;00100b:4 00110b:6;01000b:8
(2-2-2) Fast Read Number of Mode Clocks		23 : 21	000b	Mode Clocks: 000b:Not supported;010:2 clocks
(2-2-2)Fast Read Instruction	47h	31 : 24	FFh	

Table 5.4 Basic SPI Flash Parameter, JEDEC Flash Parameter Tables (Sheet 7 of 9)

Description	Add (h) (Byte)	DW Add (Bit)	Data	Comment
Unused	49h : 48h	15 : 00	FFFFh	
(4-4-4)Fast Read Number of Wait states	4Ah	20 : 16	00010b	00000b:Not supported; 00010b:2;00100b:4; 00110b:6;01000b:8
(4-4-4) Fast Read Number of Mode Clocks		23 : 21	010b	Mode Clocks: 000b:Not supported;010:2 clocks
(4-4-4)Fast Read Instruction	4Bh	31 : 24	EBh	

Table 5.4 Basic SPI Flash Parameter, JEDEC Flash Parameter Tables (Sheet 8 of 9)

Description	Add (h) (Byte)	DW Add (Bit)	Data	Comment
Erase Type 1 Size	4Ch	07 : 00	0Ch	Sector/block size=2 <sup>N</sup> bytes <sup>(4)</sup> 0Ch:4KB;0Fh:32KB;10h:64KB
Erase Type 1 Erase Instruction	4Dh	15 : 08	20h	
Erase Type 2 Size	4Eh	23 : 16	0Fh	Sector/block size=2 <sup>N</sup> bytes 00h:NA;0Fh:32KB;10h:64KB
Erase Type 2 Erase Instruction	4Fh	31 : 24	52h	

Table 5.4 Basic SPI Flash Parameter, JEDEC Flash Parameter Tables (Sheet 9 of 9)

Description	Add (h) (Byte)	DW Add (Bit)	Data	Comment
Erase Type 3 Size	50h	07 : 00	10h	Sector/block size=2 <sup>N</sup> bytes 00h:NA;0Fh:32KB;10h:64KB
Erase Type 3 Erase Instruction	51h	15 : 08	D8h	
Erase Type 4 Size	52h	23 : 16	00h	Sector/block size=2 <sup>N</sup> bytes 00h:NA;0Fh:32KB;10h:64KB
Erase Type 4 Erase Instruction	53h	31 : 24	FFh	Not support

Table 5.5 Basic SPI Flash Parameter, XMC Flash Parameter Tables

Description	Add (h) (Byte)	DW Add (Bit)	Data	Comment	
Vcc supply maximum voltage	61h:60h	07:00	00h	2000h=2.000V	
		15:08	36h	2700h=2.700V 3600h=3.600V	
Vcc supply minimum voltage	63h:62h	23:16	00h	1650h=1.65V 1750h=1.75V 2250h=2.25V	
		31:24	27h	2300h=2.3V 2350h=2.35V 2650h=2.65V 2700h=2.7V	
H/W Reset# pin	65h:64h	0	F99Fh	0 = not supported 1 = supported	
H/W Hold# pin		1		0 = not supported 1 = supported	
Deep Power Down Mode		2		0 = not supported 1 = supported	
S/W Reset		3		0 = not supported 1 = supported	
S/W Reset Instruction		11:04		Reset Enable(66h)should be issued before Reset instruction	
Program suspend/resume		12		0 = not supported 1 = supported	
Erase suspend/resume		13		0 = not supported 1 = supported	
Unused		14			
Wrap-Around Read mode		15		0 = not supported 1 = supported	
Wrap-Around Read mode instruction		66h		23:16	0Ch
Wrap-Around Read data length	67h	31:24	64h	08h:support 8B wrap-around read 16h:8B&16B 32h:8B&16B&32B 64h:8B&16B&32B&64B	
Individual block lock	6Bh:68h	0	F800h	0 = not supported 1 = supported	
Individual block lock bit(Volatile/Nonvolatile)		1		0:Volatile 1:Nonvolatile	
Individual block lock Instruction		09:02			
Individual block lock Volatile protect bit default protect status		10		0:Protect 1:Unprotect	
Secured OTP		11		0 = not supported 1 = supported	
Read Lock		12		0 = not supported 1 = supported	
Permanent Lock		13		0 = not supported 1 = supported	
Unused		15:14			
Unused		31:16		FFh	
Unused		6Fh:6Ch		31:00	FFh

Note 1: (x-y-z) means I/O mode nomenclature used to indicate the number of active pins used for the instruction (x),

address (y), and data (z). At the present time, the only valid Read SFDP instruction modes are: (1-1-1), (2-2-2), and (4-4-4)

Note 2: **Wait States** is required dummy clock cycles after the address bits or optional mode clocks.

Note 3: **Mode clocks** is optional control bits that follow the address bits. These bits are driven by the system controller

if they are specified. (eg, read performance enhance toggling bits)

Note 4: 4KB=2<sup>0Ch</sup>, 32KB=2<sup>0Fh</sup>, 64KB=2<sup>10h</sup>

Note 5: All unused and undefined area data is blank FFh.

## 6. FUNCTION DESCRIPTION

### 6.1 SPI Operations

#### 6.1.1 SPI Modes

The XM25QH32B can be driven by an embedded microcontroller (bus master) in either of the two following clocking modes.

- ◆ **Mode 0** with Clock Polarity (CPOL) = 0 and, Clock Phase (CPHA) = 0
- ◆ **Mode 3** with CPOL = 1 and, CPHA = 1

For these two modes, input data is always latched in on the rising edge of the CLK signal and the output data is always available on the falling edge of the CLK clock signal.

The difference between the two modes is the clock polarity when the bus master is in standby mode and not transferring any data.

- ◆ CLK will stay at logic low state with CPOL = 0, CPHA = 0
- ◆ CLK will stay at logic high state with CPOL = 1, CPHA = 1

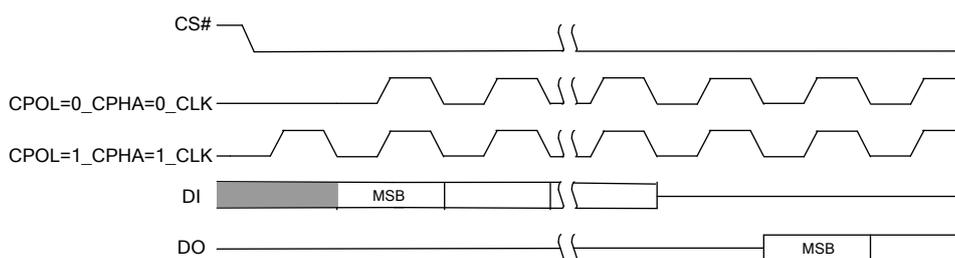


Figure 6.1 SPI Modes

Timing diagrams throughout the rest of the document are generally shown as both mode 0 and 3 by showing CLK as both high and low at the fall of CS#. In some cases a timing diagram may show only mode 0 with CLK low at the fall of CS#. In such case, mode 3 timing simply means clock is high at the fall of CS# so no CLK rising edge set up or hold time to the falling edge of CS# is needed for mode 3.

CLK cycles are measured (counted) from one falling edge of CLK to the next falling edge of CLK. In mode 0 the beginning of the first CLK cycle in a command is measured from the falling edge of CS# to the first falling edge of CLK because CLK is already low at the beginning of a command.

#### 6.1.2 Dual SPI Modes

The XM25QH32B supports Dual SPI Operation when using the Fast Read Dual Output (3Bh) and Fast Dual I/O (BBh) instruction. These features allow data to be transferred from the device at twice the rate possible with the standard SPI. These instructions are ideal for quickly downloading code to RAM upon Power-up (code-shadowing) or for executing non-speed-critical code directly from the SPI bus (XIP). When using Dual SPI commands, the DI and DO pins become bidirectional I/O pins: IO0 and IO1.

#### 6.1.3 Quad SPI Modes

The XM25QH32B supports Quad SPI operation when using the Fast Read Quad Output (6Bh), Fast Read Quad I/O (EBh) instruction, Word Read Quad I/O (E7h), and Octal Word Read Quad I/O (E3h). These instructions allow data to be transferred to or from the device four times the rate of ordinary Serial Flash. The

Quad Read instructions offer a significant improvement in continuous and random access transfer rates allowing fast code-shadowing to RAM or execution directly from the SPI bus (XIP). When using Quad SPI instructions, the DI and DO pins become bidirectional IO0 and IO1, and the WP# and HOLD# / RESET# pins become IO2 and IO3 respectively. Quad SPI instructions require the non-volatile Quad Enable bit (QE) in Status Register-2 to be set.

#### 6.1.4 QPI Function

The XM25QH32B supports Quad Peripheral Interface (QPI) operations when the device is switched from Standard/Dual/Quad SPI mode to QPI mode using the “Enter QPI (38h)” instruction. The typical SPI protocol requires that the byte-long instruction code being shifted into the device only via DI pin in eight serial clocks. The QPI mode utilizes all four IO pins to input the instruction code, thus only two serial clocks are required. This can significantly reduce the SPI instruction overhead and improve system performance in an XIP environment. Standard/Dual/Quad SPI mode and QPI mode are exclusive. Only one mode can be active at any given time. “Enter QPI (38h)” and “Exit QPI (FFh)” instructions are used to switch between these two modes. Upon power-up or after a software reset using “Reset (99h)” instruction, the default state of the device is Standard/Dual/Quad SPI mode. To enable QPI mode, the non-volatile Quad Enable bit (QE) in Status Register-2 is required to be set. When using QPI instructions, the DI and DO pins become bidirectional IO0 and IO1, and the WP# and HOLD# / RESET# pins become IO2 and IO3 respectively.

#### 6.1.5 Hold Function

For Standard SPI and Dual SPI operations, the HOLD# / RESET# (IO3) signal allows the device interface operation to be paused while it is actively selected (when CS# is low). The Hold function may be useful in cases where the SPI data and clock signals are shared with other devices. For example, if the page buffer is only partially written when a priority interrupt requires use of the SPI bus, the Hold function can save the state of the interface and the data in the buffer so programming command can resume where it left off once the bus is available again. The Hold function is only available for standard SPI and Dual SPI operation, not during Quad SPI.

To initiate a Hold condition, the device must be selected with CS# low. A Hold condition will activate on the falling edge of the HOLD# signal if the CLK signal is already low. If the CLK is not already low the Hold condition will activate after the next falling edge of CLK. The Hold condition will terminate on the rising edge of the HOLD# signal if the CLK signal is already low. If the CLK is not already low the Hold condition will terminate after the next falling edge of CLK. During a Hold condition, the Serial Data Output, (DO) or IO0 and IO1, are high impedance and Serial Data Input, (DI) or IO0 and IO1, and Serial Clock (CLK) are ignored. The Chip Select (CS#) signal should be kept active (low) for the full duration of the Hold operation to avoid resetting the internal logic state of the device.

#### 6.1.6 Software Reset & Hardware RESET# pin

The XM25QH32B can be reset to the initial power-on state by a software Reset sequence, either in SPI mode or QPI mode. This sequence must include two consecutive commands: Enable Reset (66h) & Reset (99h). If the command sequence is successfully accepted, the device will take approximately 10us ( $t_{RST}$ ) to reset. No command will be accepted during the reset period.

XM25QH32B can also be configured to utilize a hardware RESET# pin. The HRSW bit in the Status Register-3 is the configuration bit for HOLD# pin function or RESET# pin function. When HRSW=0 (factory default), the pin acts as a HOLD# pin as described above; when HRSW =1, the pin acts as a RESET# pin. Drive the RESET# pin low for a minimum period of ~1us ( $t_{RESET}^*$ ) will reset the device to its initial power-on state. Any on-going Program/Erase operation will be interrupted and data corruption may happen. While RESET# is low, the device will not accept any command input.

If QE bit is set to 1, the HOLD# or RESET# function will be disabled, the pin will become one of the four data I/O pins.

Hardware RESET# pin has the highest priority among all the input signals. Drive RESET# low for a minimum period of ~1us ( $t_{RESET}^*$ ) will interrupt any on-going external/internal operations, regardless the status of other SPI signals (CS#, CLK, DI, DO, WP# and/or HOLD#).

**Note:**

1. While a faster RESET# pulse (as short as a few hundred nanoseconds) will often reset the device, a 1us minimum is recommended to ensure reliable operation.

## 6.2. Status Register

The Read and Write Status Registers commands can be used to provide status and control of the flash memory device.

Status Register-1 (SR1) and Status Register-2 (SR2) can be used to provide status on the availability of the flash memory array, whether the device is write enabled or disabled, the state of write protection, Quad SPI setting, Security Register lock status, and Erase / Program Suspend status.

SR1 and SR2 contain non-volatile bits in locations SR1[7:2] and SR2[6:0] that control sector protection, OTP Register Protection, Status Register Protection, and Quad mode. Bits located in SR2[7], SR1[1], and SR1[0] are read only volatile bits for suspend, write enable, and busy status. These are updated by the memory control logic. The SR1[1] write enable bit is set only by the Write Enable (06h) command and cleared by the memory control logic when an embedded operation is completed.

Write access to the non-volatile Status Register bits is controlled by the state of the non-volatile Status Register Protect bits SR1[7] and SR2[0] (SRP0, SRP1), the Write Enable command (06h) preceding a Write Status Registers command, and while Quad mode is not enabled, the WP# pin.

A volatile version of bits SR2[6], SR2[1], and SR1[7:2] that control sector protection and Quad Mode is used to control the behavior of these features after power up. During power up or software reset, these volatile bits are loaded from the non-volatile version of the Status Register bits. The Write Enable for Volatile Status Register (50h) command can be used to write these volatile bits when the command is followed by a Write Status Registers (01h/31h) command. This gives more flexibility to change the system configuration and memory protection schemes quickly without waiting for the typical non-volatile bit write cycles or affecting the endurance of the Status Register non-volatile bits.

Write access to the volatile SR1 and SR2 Status Register bits is controlled by the state of the non-volatile Status Register Protect bits SR1[7] and SR2[0] (SRP0, SRP1), the Write Enable for Volatile Status Register command (50h) preceding a Write Status Registers command, and the WP# pin while Quad mode is not enabled.

Status Register-3 (SR3) is used to configure and provide status on the variable HOLD# or RESET# function, Output Driver Strength, High Frequency Enable Bit and read latency.

Write access to the volatile SR3 Status Register bits is controlled by Write Enable for Volatile Status Register command (50h) preceding a Write Status Register command. The SRP bits do not protect SR3.

**Table 6.1 Status Register-1 (SR1)**

Bits	Field	Function	Type	Default State	Description
7	SRP0	Status Register Protect 0	Non-volatile and Volatile versions	0	0 = WP# input has no effect or Power Supply Lock Down mode 1 = WP# input can protect the Status Register or OTP Lock Down.
6	SEC	Sector / Block Protect		0	0 = BP2-BP0 protect 64-kB blocks 1 = BP2-BP0 protect 4-kB sectors
5	TB	Top / Bottom protect		0	0 = BP2-BP0 protect from the Top down 1 = BP2-BP0 protect from the Bottom up
4	BP2	Block Protect Bits		0	000b = No protection
3	BP1			0	
2	BP0		0		
1	WEL	Write Enable Latch	Volatile, Read only	0	0 = Not Write Enabled, no embedded operation can start 1 = Write Enabled, embedded operation can start
0	BUSY	Embedded Operation Status	Volatile, Read only	0	0 = Not Busy, no embedded operation in progress 1 = Busy, embedded operation in progress

**Table 6.2 Status Register-2 (SR2)**

Bits	Field	Function	Type	Default State	Description
7	SUS	Suspend Status	Volatile, Read Only	0	0 = Erase / Program not suspended 1 = Erase / Program suspended
6	CMP	Complement Protect	Non-volatile and Volatile versions	0	0 = Normal Protection Map 1 = Complementary Protection Map
5	LB3	Security Register Lock Bits	OTP	0	OTP Lock Bits 3:0 for Security Registers 3:0 0 = Security Register not protected 1 = Security Register protected Security register 0 contains the Serial Flash Discoverable Parameters and is always programmed and locked by XMC.
4	LB2			0	
3	LB1			0	
2	LB0			0	
1	QE	Quad Enable	Non-volatile and Volatile versions	0	0 = Quad Mode Not Enabled, the WP# pin and HOLD# / RESET# are enabled 1 = Quad Mode Enabled, the IO2 and IO3 pins are enabled, and WP# and HOLD# / RESET# functions are disabled
0	SRP1	Status Register Protect 1		0	0 = SRP1 selects whether WP# input has effect on protection of the status register 1 = SRP1 selects Power Supply Lock Down or OTP Lock Down mode

**Note:**

1. A Software/Hardware reset or Power Down reset is required before non-volatile Status Register bits writing(06h+01/31h) when writing volatile Status Register command(50h+01h/31h) has been issued earlier within one power up-power down cycle.
2. When write non-volatile Status Register bits(06h+01/31h), please contact XMC sales representative for the application note of polling status bit check.

**Table 6.3 Status Register-3 (SR3)**

Bits	Field	Function	Type	Default State	Description
7	HRSW <sup>(1)</sup>	HOLD# or RESET# function	Volatile	0	When HRSW=0, the pin acts as HOLD#; when HRSW=1, the pin acts as RESET#. HRSW functions are only available when QE=0.
6	DRV1 <sup>(1)</sup>	Output Driver Strength		1	The DRV1 & DRV0 bits are used to determine the output driver strength for the Read operations.
5	DRV0 <sup>(1)</sup>			0	
4	HFM	High Frequency Mode Enable Bit		0	0= QPI High Frequency Mode Disabled 1 = QPI High Frequency Mode Enabled
3	Latency Control (LC) <sup>(2)</sup>	Variable SPI Read Latency Control		0	Defines the number of read latency cycles in Fast Read, Dual Out, Quad Out, Dual IO, and Quad IO commands. Binary values for 1 to 15 latency cycles. A value of zero disables the variable latency mode.
2				0	
1				0	
0				0	

**Note:**

1. Default state for these three bits could be modified. please contact sales.

2. LC[3:0] only controls SPI read latency and will be reset to default while switching from QPI to SPI. QPI read latency is set by C0 instruction.

**6.2.1 BUSY**

BUSY is a read only bit in the status register (SR1[0]) which is set to a “1” state when the device is executing a Page Program, Sector Erase, Block Erase, Chip Erase or Write Status Register instruction. During this time the device will ignore further instructions except for the Read Status Register instruction (see  $t_W$ ,  $t_{PP}$ ,  $t_{SE}$ ,  $t_{BE}$ , and  $t_{CE}$  in AC Characteristics). When the program, erase or write status register instruction has completed, the BUSY bit will be cleared to a “0” state indicating the device is ready for further instructions.

**6.2.2 Write Enable Latch (WEL)**

Write Enable Latch (WEL) is a read only bit in the status register (SR1[1]) which is set to a 1 after executing a Write Enable Instruction. The WEL status bit is cleared to a 0 when the device is written disabled. A write disable state occurs upon power-up or after any of the following instructions: Write Disable, Page Program, Sector Erase, Block Erase, Chip Erase and Write Status Register.

**6.2.3 Block Protect Bits (BP2, BP1, BP0)**

The Block Protect Bits (BP2, BP1, BP0) are non-volatile read / write bits in the Status Register (SR1[4:2]) that provide Write Protection control and status. Block Protect bits can be set using the Write Status Registers Command (see  $t_W$  in Section 8.5). All, none or a portion of the memory array can be protected from Program and Erase commands (see Section 6.4.2, Block Protection Maps). The factory default setting for the Block Protection Bits is 0 (none of the array is protected.)

**6.2.4 Top / Bottom Block Protect (TB)**

The non-volatile Top / Bottom bit (TB SR1[5]) controls whether the Block Protect Bits (BP2, BP1, BP0) protect from the Top (TB=0) or the Bottom (TB=1) of the array as shown in Section 6.4.2, Block Protection Maps. The factory default setting is TB=0. The TB bit can be set with the Write Status Registers Command depending on the state of the SRP0, SRP1 and WEL bits.

**6.2.5 Sector / Block Protect (SEC)**

The non-volatile Sector / Block Protect bit (SEC SR1[6]) controls if the Block Protect Bits (BP2, BP1, BP0) protect either 4-kB Sectors (SEC=1) or 64-kB Blocks (SEC=0) of the array as shown in Section 6.4.2, Block Protection Maps. The default setting is SEC=0.

### 6.2.6 Complement Protect (CMP)

The Complement Protect bit (CMP SR2[6]) is a non-volatile read / write bit in the Status Register (SR2[6]). It is used in conjunction with SEC, TB, BP2, BP1 and BP0 bits to provide more flexibility for the array protection. Once CMP is set to 1, previous array protection set by SEC, TB, BP2, BP1 and BP0 will be reversed. For instance, when CMP=0, a top 4-kB sector can be protected while the rest of the array is not; when CMP=1, the top 4-kB sector will become unprotected while the rest of the array become read-only. Refer to Section 6.4.2, Block Protection Maps for details. The default setting is CMP=0.

### 6.2.7 The Status Register Protect (SRP1, SRP0)

The Status Register Protect bits (SRP1 and SRP0) are non-volatile read / write bits in the Status Register (SR2[0] and SR1[7]). The SRP bits control the method of write protection: software protection, hardware protection, power supply lock-down, or one time programmable (OTP) protection.

Table 6.4 Status Register Protect

SRP1	SRP0	WP#	Status Register	Description
0	0	X	Software Protection	WP# pin has no control. SR1 and SR2 can be written to after a Write Enable command, WEL=1. [Factory Default]
0	1	0	Hardware Protected	When WP# pin is low the SR1 and SR2 are locked and cannot be written.
0	1	1	Hardware Unprotected	When WP# pin is high SR1 and SR2 are unlocked and can be written to after a Write Enable command, WEL=1.
1	0	X	Power Supply Lock Down	SR1 and SR2 are protected and cannot be written to again until the next power-down, power-up cycle. <sup>(1)</sup>
1	1	X	One Time Program <sup>(2)</sup>	SR1 and SR2 are permanently protected and cannot be written.

**Notes:**

1. When SRP1, SRP0 = (1, 0), a power-down, power-up, or Software Reset cycle will change SRP1, SRP0 to (0, 0) state.
2. The One-Time Program feature is available upon special order. Contact XMC for details.
3. Busy, WEL, and SUS (SR1[1:0] and SR2[7]) are volatile read only status bits that are never affected by the Write Status Registers command.
4. The non-volatile version of CMP, QE, SRP1, SRP0, SEC, TB, and BP2-BP0 (SR2[6,1,0] and SR1[6:2]) bits and the OTP LB3-LB0 bits are not writable when protected by the SRP bits and WP# as shown in the table. The non-volatile version of these Status Register bits is selected for writing when the Write Enable (06h) command precedes the Write Status Registers (01h) command.
5. The volatile version of CMP, QE, SRP1, SRP0, SEC, TB, and BP2-BP0 (SR2[6,1,0] and SR1[6:2]) bits are not writable when protected by the SRP bits and WP# as shown in the table. The volatile version of these Status Register bits is selected for writing when the Write Enable for volatile Status Register (50h) command precedes the Write Status Registers (01h) command. There is no volatile version of the LB3-LB0 bits and these bits are not affected by a volatile Write Status Registers command.
6. The volatile SR3 bits are not protected by the SRP bits and may be written at any time by volatile (50h) Write Enable command preceding the Write Status Registers (01h/11h) command.

### 6.2.8 Erase / Program Suspend Status (SUS)

The Suspend Status bit is a read only bit in the status register (SR2[7]) that is set to 1 after executing an Erase / Program Suspend (75h) command. The SUS status bit is cleared to 0 by Erase / Program Resume (7Ah) command as well as a power-down, power-up cycle.

### 6.2.9 Security Register Lock Bits (LB3, LB2, LB1, LB0)

The Security Register Lock Bits (LB3, LB2, LB1, LB0) are non-volatile One Time Program (OTP) bits in Status Register (SR2[5:2]) that provide the write protect control and status to the Security Registers. The default state of LB[3:1] is 0, Security Registers 1 to 3 are unlocked. LB[3:1] can be set to 1 individually using

the Write Status Registers command. LB[3:1] are One Time Programmable (OTP), once it's set to 1, the corresponding 256-byte Security Register will become read-only permanently. Security Register 0 is programmed with the SFDP parameters and LB0 is programmed to 0 by XMC.

### 6.2.10 Quad Enable (QE)

The Quad Enable (QE) bit is a non-volatile read / write bit in the Status Register (SR2[1]) that allows Quad SPI operation. When the QE bit is set to a 0 state (factory default), the WP# pin and HOLD# / RESET# are enabled. When the QE bit is set to a 1, the Quad IO2 and IO3 pins are enabled, and WP# and HOLD# / RESET# functions are disabled.

**Note:** If the WP# or HOLD# / RESET# pins are tied directly to the power supply or ground during standard SPI or Dual SPI operation, the QE bit should never be set to a 1.

### 6.2.11 HOLD# or RESET# Pin Function (HRSW)

The HRSW bit is used to determine whether HOLD# or RESET# function should be implemented on the hardware pin for 8-pin packages. When HRSW=0, the pin acts as #HOLD; when HRSW=1, the pin acts as RESET#. However, HOLD# or RESET# functions are only available when QE=0. If QE is set to 1, the HOLD# and RESET# functions are disabled, the pin acts as a dedicated data I/O pin.

### 6.2.12 Output Driver Strength (DRV1, DRV0)

The DRV1 & DRV0 bits are used to determine the output driver strength for the Read operations.

DRV1, DRV0	Driver Strength
0, 0	50%
0, 1	25%
1, 0	75%(default)
1, 1	100%

### 6.2.13 High Frequency Mode Enable Bit (HFM)

The HFM bit is used to determine whether the device is in QPI High Frequency Mode. When HFM bit sets to 1, it means the device is in QPI High Frequency Mode, when HFM bit sets 0 (default), it means the device is not in QPI High Frequency Mode. This Mode allows pre-charge of internal charge pump, so the voltages required for accessing the flash memory array are readily available for QPI read. After the HFM is executed, the device will maintain a slightly higher standby current (ICC8) than standard SPI operation.

### 6.2.14 Latency Control (LC)

Status Register-3 provides bits (SR3[3:0]) to select the number of read latency cycles used in each Fast Read command(only in SPI mode). The Read Data command is not affected by the latency code. The binary value of this field selects from 1 to 15 latency cycles. The default is 0 to provide backward compatibility to legacy devices. The Latency Control bits may be set to select a number of read cycles optimized for the frequency in use. If the number of latency cycles is not sufficient for the operating frequency, invalid data will be read.

**Table 6.5 Latency Cycles Versus Frequency for -40°C to 85°C/105°C at 2.7V to 3.6V**

Latency Control	Read Command Maximum Frequency (MHz)					
	Fast Read	Dual Output	Dual I/O	Quad Output	Quad I/O	Word Read Quad I/O
0 (legacy read latency)	104 (8 dummy)	104 (8 dummy)	104 (4 mode, 0 dummy)	104 (8 dummy)	104 (2 mode, 4 dummy)	104 (2 mode, 2 dummy)
1	95	95	104	75	60	90
2	104	104	104	90	75	104
3	104	104	104	104	90	104
4	104	104	104	104	104	104
5	104	104	104	104	104	104
6	104	104	104	104	104	104
7	104	104	104	104	104	104
8	104	104	104	104	104	104
9	104	104	104	104	104	104
10	104	104	104	104	104	104
11	104	104	104	104	104	104
12	104	104	104	104	104	104
13	104	104	104	104	104	104
14	104	104	104	104	104	104
15	104	104	104	104	104	104

**Notes:**

1. The default dummy referred in this document is the dummy configuration when LC[3:0]=0.
2. Value guaranteed by design and/or characterization, not 100% tested in production.

### 6.3. Write Protection

Applications that use non-volatile memory must take into consideration the possibility of noise and other adverse system conditions that may compromise data integrity. To address this concern the XM25QH32B provides the following data protection mechanisms:

#### 6.3.1 Write Protect Features

- ◆ Device resets when  $V_{CC}$  is below threshold
- ◆ Time delay write disable after Power-Up
- ◆ Write enable / disable commands and automatic write disable after erase or program
- ◆ Command length protection
  - All commands that Write, Program or Erase must complete on a byte boundary (CS# driven high after a full 8 bits have been clocked) otherwise the command will be ignored.
- ◆ Software and Hardware write protection using Status Register control
  - WP# input protection
  - Lock Down write protection until next power-up or Software Reset
  - One-Time Program (OTP) write protection
- ◆ Write Protection using the Deep Power-Down command

Upon power-up or at power-down, the XM25QH32B will maintain a reset condition while  $V_{CC}$  is below the threshold value of VWI, (see Figure 8.1). While reset, all operations are disabled and no commands are recognized. During power-up and after the  $V_{CC}$  voltage exceeds VWI, all program and erase related commands are further disabled for a time delay of tPUW. This includes the Write Enable, Page Program, Sector Erase, Block Erase, Chip Erase and the Write Status Registers commands. Note that the chip select

pin (CS#) must track the  $V_{CC}$  supply level at power-up until the  $V_{CC-min}$  level and  $t_{VSL}$  time delay is reached. If needed a pull-up resistor on CS# can be used to accomplish this.

After power-up the device is automatically placed in a write-disabled state with the Status Register Write Enable Latch (WEL) set to a 0. A Write Enable command must be issued before a Page Program, Sector Erase, Block Erase, Chip Erase or Write Status Registers command will be accepted. After completing a program, erase or write command the Write Enable Latch (WEL) is automatically cleared to a write-disabled state of 0.

Software controlled main flash array write protection is facilitated using the Write Status Registers command to write the Status Register (SR1,SR2) and Block Protect (SEC, TB, BP2, BP1 and BP0) bits.

The BP method allows a portion as small as 4-kB sector or the entire memory array to be configured as read only. Used in conjunction with the Write Protect (WP#) pin, changes to the Status Register can be enabled or disabled under hardware control. See the Table 6.4 for further information.

Additionally, the Deep Power-Down (DPD) command offers an alternative means of data protection as all commands are ignored during the DPD state, except for the Release from Deep-Power-Down (RES ABh) command. Thus, preventing any program or erase during the DPD state.

**6.3.2 Block Protection Maps**

Table 6.6 XM25QH32B Block Protection (CMP = 0)

Status Register <sup>(1)</sup>					XM25QH32B(32 Mbit) Block Protection (CMP=0) <sup>(2)</sup>			
SEC	TB	BP2	BP1	BP0	Protected Block(s)	Protected Addresses	Protected Density	Protected Portion
X	X	0	0	0	None	None	None	None
0	0	0	0	1	63	3F0000h – 3FFFFFFh	64 kB	Upper 1/64
0	0	0	1	0	62 and 63	3E0000h – 3FFFFFFh	128 kB	Upper 1/32
0	0	0	1	1	60 thru 63	3C0000h – 3FFFFFFh	256 kB	Upper 1/16
0	0	1	0	0	56 thru 63	380000h – 3FFFFFFh	512 kB	Upper 1/8
0	0	1	0	1	48 thru 63	300000h – 3FFFFFFh	1 MB	Upper 1/4
0	0	1	1	0	32 thru 63	200000h – 3FFFFFFh	2MB	Upper 1/2
0	1	0	0	1	0	000000h – 00FFFFh	64 kB	Lower 1/64
0	1	0	1	0	0 and 1	000000h – 01FFFFh	128 kB	Lower 1/32
0	1	0	1	1	0 thru 3	000000h – 03FFFFh	256 kB	Lower 1/16
0	1	1	0	0	0 thru 7	000000h – 07FFFFh	512 kB	Lower 1/8
0	1	1	0	1	0 thru 15	000000h – 0FFFFFFh	1 MB	Lower 1/4
0	1	1	1	0	0 thru 31	000000h – 1FFFFFFh	2 MB	Lower 1/2
X	X	1	1	1	0 thru 63	000000h – 3FFFFFFh	4 MB	All
1	0	0	0	1	63	3FF000h – 3FFFFFFh	4 kB	Upper 1/1024
1	0	0	1	0	63	3FE000h – 3FFFFFFh	8 kB	Upper 1/512
1	0	0	1	1	63	3FC000h – 3FFFFFFh	16 kB	Upper 1/256
1	0	1	0	X	63	3F8000h – 3FFFFFFh	32 kB	Upper 1/128
1	0	1	1	0	63	3F8000h – 3FFFFFFh	32 kB	Upper 1/128
1	1	0	0	1	0	000000h – 000FFFh	4 kB	Lower 1/1024
1	1	0	1	0	0	000000h – 001FFFh	8 kB	Lower 1/512
1	1	0	1	1	0	000000h – 003FFFh	16 kB	Lower 1/256
1	1	1	0	X	0	000000h – 007FFFh	32 kB	Lower 1/128
1	1	1	1	0	0	000000h – 007FFFh	32 kB	Lower 1/128

**Notes:**

1. X = don't care.
2. If any Erase or Program command specifies a memory region that contains protected data portion, this command will be ignored.

**Table 6.7 XM25QH32B Block Protection (CMP = 1)**

Status Register <sup>(1)</sup>					XM25QH32B(32 Mbit) Block Protection (CMP=1) <sup>(2)</sup>			
SEC	TB	BP2	BP1	BP0	Protected Block(s)	Protected Addresses	Protected Density	Protected Portion
X	X	0	0	0	0 thru 63	000000h – 3FFFFFFh	4 MB	All
0	0	0	0	1	0 thru 62	000000h – 3EFFFFh	4032 kB	Lower 63/64
0	0	0	1	0	0 thru 61	000000h – 3DFFFFh	3986 kB	Lower 31/32
0	0	0	1	1	0 thru 59	000000h – 3BFFFFh	3840 kB	Lower 15/16
0	0	1	0	0	0 thru 55	000000h – 37FFFFh	3584 kB	Lower 7/8
0	0	1	0	1	0 thru 47	000000h – 2FFFFFFh	3 MB	Lower 3/4
0	0	1	1	0	0 thru 31	000000h – 1FFFFFFh	2 MB	Lower 1/2
0	1	0	0	1	1 thru 63	010000h – 3FFFFFFh	4032 kB	Upper 63/64
0	1	0	1	0	2 thru 63	020000h – 3FFFFFFh	3986 kB	Upper 31/32
0	1	0	1	1	4 thru 63	040000h – 3FFFFFFh	3840 kB	Upper 15/16
0	1	1	0	0	8 thru 63	080000h – 3FFFFFFh	3584 kB	Upper 7/8
0	1	1	0	1	16 thru 63	100000h – 3FFFFFFh	3 MB	Upper 3/4
0	1	1	1	0	32 thru 63	200000h – 3FFFFFFh	2 MB	Upper 1/2
X	X	1	1	1	None	None	None	None
1	0	0	0	1	0 thru 63	000000h – 3FEFFFh	4092 kB	Lower 1023/1024
1	0	0	1	0	0 thru 63	000000h – 3FDFFFh	4088 kB	Lower 511/512
1	0	0	1	1	0 thru 63	000000h – 3FBFFFh	4080 kB	Lower 255/256
1	0	1	0	X	0 thru 63	000000h – 3F7FFFh	4064 kB	Lower 127/128
1	0	1	1	0	0 thru 63	000000h – 3F7FFFh	4064 kB	Lower 127/128
1	1	0	0	1	0 thru 63	001000h – 3FFFFFFh	4092 kB	Upper 1023/1024
1	1	0	1	0	0 thru 63	002000h – 3FFFFFFh	4088 kB	Upper 511/512
1	1	0	1	1	0 thru 63	004000h – 3FFFFFFh	4080 kB	Upper 255/256
1	1	1	0	X	0 thru 63	008000h – 3FFFFFFh	4064 kB	Upper 127/128
1	1	1	1	0	0 thru 63	008000h – 3FFFFFFh	4064 kB	Upper 127/128

**Notes:**

1. X = don't care.
2. If any Erase or Program command specifies a memory region that contains protected data portion, this command will be ignored.

## 6.4. Page Program

To program one data byte, two instructions are required: Write Enable (WREN), which is one byte, and a Page Program (PP) sequence, which consists of four bytes plus data. This is followed by the internal Program cycle (of duration  $t_{PP}$ ). To spread this overhead, the Page Program (PP) instruction allows up to 256 bytes to be programmed at a time (changing bits from 1 to 0), provided that they lie in consecutive addresses on the same page of memory.

## 6.5. Sector Erase, Block Erase and Chip Erase

The Page Program (PP) instruction allows bits to be reset from 1 to 0. Before this can be applied, the bytes of memory need to be erased to all 1s (FFh). This can be achieved a sector at a time, using the Sector Erase (SE) instruction, a block at a time using the Block Erase (BE) instruction or throughout the entire memory, using the Chip Erase (CE) instruction. This starts an internal Erase cycle (of duration  $t_{SE}$ ,  $t_{BE}$  or  $t_{CE}$ ). The Erase instruction must be preceded by a Write Enable (WREN) instruction.

## 6.6. Polling during a Write, Program or Erase Cycle

A further improvement in the time to Write Status Register (WRSR), Program (PP) or Erase (SE, BE or CE) can be achieved by not waiting for the worst case delay ( $t_W$ ,  $t_{PP}$ ,  $t_{SE}$ ,  $t_{BE}$  or  $t_{CE}$ ). The Write In Progress (WIP) bit is provided in the Status Register so that the application program can monitor its value, polling it to establish when the previous Write cycle, Program cycle or Erase cycle is complete.

## 6.7. Active Power, Stand-by Power and Deep Power-Down Modes

When Chip Select (CS#) is Low, the device is enabled, and in the Active Power mode. When Chip Select (CS#) is High, the device is disabled, but could remain in the Active Power mode until all internal cycles have completed (Program, Erase, Write Status Register). The device then goes into the Standby Power mode. The device consumption drops to ICC1.

The Deep Power-down mode is entered when the specific instruction (the Enter Deep Power-down Mode (DP) instruction) is executed. The device consumption drops further to ICC2. The device remains in this mode until another specific instruction (the Release from Deep Power-down Mode and Read Device ID (RDI) instruction) is executed.

All other instructions are ignored while the device is in the Deep Power-down mode. This can be used as an extra software protection mechanism, when the device is not in active use, to protect the device from inadvertent Program or Erase instructions.

## 7. INSTRUCTIONS

The instruction set of the XM25QH32B consists of forty basic instructions that are fully controlled through the SPI bus. Instructions are initiated with the falling edge of Chip Select (CS#). The first byte of data clocked into the DI input provides the instruction code. Data on the DI input is sampled on the rising edge of clock with most significant bit (MSB) first.

The QPI instruction set of the XM25QH32B consists of 32 basic instructions that are fully controlled through the SPI bus (see Instruction Set Table 7.5). Instructions are initiated with the falling edge of Chip Select (CS#). The first byte of data clocked through IO[3:0] pins provides the instruction code. Data on all four IO pins are sampled on the rising edge of clock with most significant bit (MSB) first. All QPI instructions, addresses, data and dummy bytes are using all four IO pins to transfer every byte of data with every two serial clocks (CLK).

Instructions vary in length from a single byte to several bytes and may be followed by address bytes, data bytes, dummy bytes (don't care), and in some cases, a combination. Instructions are completed with the rising edge of edge CS#. Clock relative timing diagrams for each instruction are included in figures 7.1 through 7.43. All read instructions can be completed after any clocked bit. However, all instructions that Write, Program or Erase must complete on a byte boundary (CS driven high after a full 8-bits have been clocked) otherwise the instruction will be ignored. This feature further protects the device from inadvertent writes. Additionally, while the memory is being programmed or erased, or when the Status Register is being written, all instructions except for Read Status Register and Erase/Program Suspend will be ignored until the program or erase cycle completes.

**Table 7.1 Command Set (Configuration, Status, Erase, Program Instructions <sup>(1)</sup>, SPI Mode)**

Command Name	BYTE 1 (Instruction)	BYTE 2	BYTE 3	BYTE 4	BYTE 5	BYTE 6
Read Status Register-1	05h	SR1[7:0] <sup>(2)</sup>				
Read Status Register-2	35h	SR2[7:0] <sup>(2)</sup>				
Read Status Register-3	15h/33h	SR3[7:0] <sup>(2)</sup>				
Write Enable	06h					
Write Enable for Volatile Status Register	50h					
Write Disable	04h					
Write Status Registers-1	01h	SR1[7:0] <sup>(5)</sup>				
Write Status Registers-2	31h	SR2[7:0]				
Write Status Registers-3	11h	SR3[7:0]				
Set Burst with Wrap	77h	xxh	xxh	xxh	W[7:0] <sup>(3)</sup>	
Page Program	02h	A23—A16	A15—A8	A7—A0	D7—D0	
Quad Page Program	32h	A23—A16	A15—A8	A7—A0	D7—D0 <sup>(4)</sup>	
Sector Erase (4 KB)	20h	A23—A16	A15—A8	A7—A0		
Block Erase (32 KB)	52h	A23—A16	A15—A8	A7—A0		
Block Erase (64 KB)	D8h	A23—A16	A15—A8	A7—A0		
Chip Erase	C7h/60h					
Erase/Program Suspend	75h					
Erase/Program Resume	7Ah					
Enter QPI Mode	38h					
Enable Reset	66h					
Reset Device	99h					

**Notes:**

- Data bytes are shifted with Most Significant Bit first. Byte fields with data in parenthesis “( )” indicate data being read from the device on the DO pin.
- Status Register contents will repeat continuously until CS# terminates the command.
- Set Burst with Wrap Input format.  
 IO0 = x, x, x, x, x, x, W4, x]  
 IO1 = x, x, x, x, x, x, W5, x]  
 IO2 = x, x, x, x, x, x, W6 x]  
 IO3 = x, x, x, x, x, x, x, x
- Quad Page Program Input Data:  
 IO0 =(D4,D0,...)  
 IO1 = ( D5,D1,...)  
 IO2 = ( D6,D2,...)  
 IO3 =( D7,D3,...)
- The 01h command could continuously write up to three bytes to registers SR1, SR2, SR3.

**Table 7.2 Command Set (Read Instructions <sup>(1)</sup>, SPI Mode)**

Command Name	BYTE 1 (Instruction)	BYTE 2	BYTE 3	BYTE 4	BYTE 5	BYTE 6
Read Data	03h	A23—A16	A15—A8	A7—A0	(D7—D0,...)	
Fast Read	0Bh	A23—A16	A15—A8	A7—A0	dummy	(D7—D0,...)
Fast Read Dual Output	3Bh	A23—A16	A15—A8	A7—A0	dummy	(D7—D0,...) <sup>(1)</sup>
Fast Read Quad Output	6Bh	A23—A16	A15—A8	A7—A0	dummy	(D7—D0,...) <sup>(3)</sup>
Fast Read Dual I/O	BBh	A23—A8 <sup>(2)</sup>	A7—A0,M7—M0 <sup>(2)</sup>	(D7—D0,...) <sup>(1)</sup>		
Fast Read Quad I/O	EBh	A23—A0,M7—M0 <sup>(4)</sup>	(x,x,x,x,D7—D0,...)	(D7—D0,...) <sup>(3)</sup>		
QUAD I/O WORD FAST READ <sup>(5)</sup>	E7H	A23—A0,M7—M0 <sup>(4)</sup>	(x,x,D7—D0,...)	(D7—D0,...) <sup>(3)</sup>		
Octal Word Read Quad I/O <sup>(5)</sup>	E3h	A23—A0,M7—M0 <sup>(4)</sup>	(D7—D0,...) <sup>(3)</sup>	(D7—D0,...) <sup>(3)</sup>		

**Notes:**

- Dual Output data  
IO0 = (D6, D4, D2, D0)  
IO1 = (D7, D5, D3, D1)
- Dual Input Address  
IO0 = A22, A20, A18, A16, A14, A12, A10, A8 A6, A4, A2, A0, M6, M4, M2, M0  
IO1 = A23, A21, A19, A17, A15, A13, A11, A9 A7, A5, A3, A1, M7, M5, M3, M1
- Quad Output Data  
IO0 = (D4, D0, .....)  
IO1 = (D5, D1, .....)  
IO2 = (D6, D2, .....)  
IO3 = (D7, D3, .....)
- Quad Input Address  
IO0 = A20, A16, A12, A8, A4, A0, M4, M0  
IO1 = A21, A17, A13, A9, A5, A1, M5, M1  
IO2 = A22, A18, A14, A10, A6, A2, M6, M2  
IO3 = A23, A19, A15, A11, A7, A3, M7, M3
- For Word Read Quad I/O, the lowest address bit must be 0. (A0 = 0), and for Octal Word Read Quad I/O, the lowest four address bits must be 0. (A3, A2, A1, A0 = 0)

**Table 7.3 Command Set (Read ID, OTP Instructions <sup>(1)</sup>, SPI Mode)**

Command Name	BYTE 1 (Instruction)	BYTE 2	BYTE 3	BYTE 4	BYTE 5	BYTE 6
Deep Power-down	B9h					
Release Power down / Device ID	ABh	dummy	dummy	dummy	Device ID <sup>(1)</sup>	
Manufacturer/ Device ID <sup>(2)</sup>	90h	dummy	dummy	00h	Manufacturer	Device ID
Manufacturer/ Device ID by Dual I/O	92h	A23—A8	A7—A0,M[7:0]	(MF[7:0],ID[7:0])		
JEDEC ID	9Fh	Manufacturer	Memory Type	Capacity		
Read SFDP Register	5Ah	00h	00h	A7—A0	dummy	(D7—D0,...)
Read Security Registers <sup>(3)</sup>	48h	A23—A16	A15—A8	A7—A0	dummy	(D7—D0,...)
Erase Security Registers <sup>(3)</sup>	44h	A23—A16	A15—A8	A7—A0		
Program Security Registers <sup>(3)</sup>	42h	A23—A16	A15—A8	A7—A0	D7—D0,...	
Read Unique ID	4Bh	dummy	dummy	dummy	dummy	(ID63-ID0)

**Notes:**

- The Device ID will repeat continuously until CS# terminates the command.
- See Section 6.4.1, Legacy Device Identification Commands on page 51 for Device ID information. The 90h instruction is followed by an address. Address = 0 selects Manufacturer ID as the first returned data as shown in the table. Address = 1 selects Device ID as the first returned data followed by Manufacturer ID.
- Security Register Address:  
 Security Register 0: A23-16 = 00h; A15-8 = 00h; A7-0 = byte address  
 Security Register 1: A23-16 = 00h; A15-8 = 10h; A7-0 = byte address  
 Security Register 2: A23-16 = 00h; A15-8 = 20h; A7-0 = byte address  
 Security Register 3: A23-16 = 00h; A15-8 = 30h; A7-0 = byte address

**Table 7.4<sup>(1)</sup> Manufacturer and Device Identification(SPI and QPI Mode)**

OP Code	Data1	Data2	Data3
ABh	Device ID = 15h	-	-
90h/92h	Manufacturer ID = 20h	Device ID = 15h	-
9Fh(SPI Mode)	Manufacturer ID = 20h	Memory Type =40h <sup>(2)</sup>	Capacity = 16h
9Fh(QPI Mode)	Manufacturer ID = 20h	Memory Type =60h <sup>(2)</sup>	Capacity = 16h

**Notes:**

- Please contact sales for more information
- Data2 40h is for SPI mode and the 60h is for QPI mode.

**Table 7.5 Command Set (QPI Instructions <sup>(1)</sup>, QPI Mode)**

Command Name	BYTE 1 (Instruction)	BYTE 2	BYTE 3	BYTE 4	BYTE 5	BYTE 6
Clock Number	(0, 1)	(2, 3)	(4, 5)	(6, 7)	(8, 9)	(10, 11)
Write Enable	06h					
Write Enable for Volatile Status Register	50h					
Write Disable	04h					
Read Status Register-1	05h	(S7-S0) <sup>(1)</sup>				
Write Status Register-1 <sup>(3)</sup>	01h	(S7-S0) <sup>(3)</sup>				
Read Status Register-2	35h	(S15-S8) <sup>(1)</sup>				
Write Status Register-2	31h	(S15-S8)				
Read Status Register-3	15h/33h	(S23-S16) <sup>(1)</sup>				
Write Status Register-3	11h	(S23-S16)				
Chip Erase	C7h/60h					
Erase / Program Suspend	75h					
Erase / Program Resume	7Ah					
Deep Power-down	B9h					
Set Read Parameters	C0h	P7-P0				
Release Power down / ID	ABh	Dummy	Dummy	Dummy	(ID7-ID0) <sup>(1)</sup>	
Manufacturer/Device ID	90h	Dummy	Dummy	00h	(MF7-MF0)	(ID7-ID0)
JEDEC ID	9Fh	(MF7-MF0)	(ID15-ID8)	(ID7-ID0)		
Exit QPI Mode	FFh					
Enable Reset	66h					
Reset Device	99h					
Page Program	02h	A23-A16	A15-A8	A7-A0	D7-D0 <sup>(4)</sup>	D7-D0 <sup>(2)</sup>
Sector Erase (4KB)	20h	A23-A16	A15-A8	A7-A0		
Block Erase (32KB)	52h	A23-A16	A15-A8	A7-A0		
Block Erase (64KB)	D8h	A23-A16	A15-A8	A7-A0		
Fast Read	0Bh	A23-A16	A15-A8	A7-A0	Dummy <sup>(5)</sup>	D7-D0
Burst Read with Wrap <sup>(6)</sup>	0Ch	A23-A16	A15-A8	A7-A0	Dummy <sup>(5)</sup>	D7-D0
Fast Read Quad I/O	EBh	A23-A16	A15-A8	A7-A0	M7-M0 <sup>(5)</sup>	D7-D0

**Notes:**

1. The Status Register contents and Device ID will repeat continuously until CS# terminates the instruction.
2. At least one byte of data input is required for Page Program, Quad Page Program and Program Security Registers, up to 256 bytes of data input. If more than 256 bytes of data are sent to the device, the addressing will wrap to the beginning of the page and overwrite previously sent data.
3. Write Status Register-1 (01h) can also be used to program Status Register-1&2&3, see section 7.1.5.
4. Quad SPI data input/output format:  
 IO0 = (D4, D0, .....)  
 IO1 = (D5, D1, .....)  
 IO2 = (D6, D2, .....)  
 IO3 = (D7, D3, .....)
5. The number of dummy clocks for QPI Fast Read, QPI Fast Read Quad I/O & QPI Burst Read with Wrap is controlled by read parameter P7 – P4.
6. The wrap around length for QPI Burst Read with Wrap is controlled by read parameter P3 – P0.

## 7.1 Configuration and Status Commands

### 7.1.1 Read Status Register (05h/35h/15h)

The Read Status Register commands allow the 8-bit Status Registers to be read. The command is entered by driving CS# low and shifting the instruction code “05h” for Status Register-1, “35h” for Status Register-2, “15h” for Status Register-3 into the DI pin on the rising edge of CLK. The Status Register bits are then shifted out on the DO pin at the falling edge of CLK with most significant bit (MSB) first as shown in Figure 7.1. The Status Register bits are shown in Section 6.2, Status Registers.

The Read Status Register-1 (05h) command may be used at any time, even during a Program, Erase, or Write Status Registers cycle. This allows the BUSY status bit to be checked to determine when the operation is complete and if the device can accept another command.

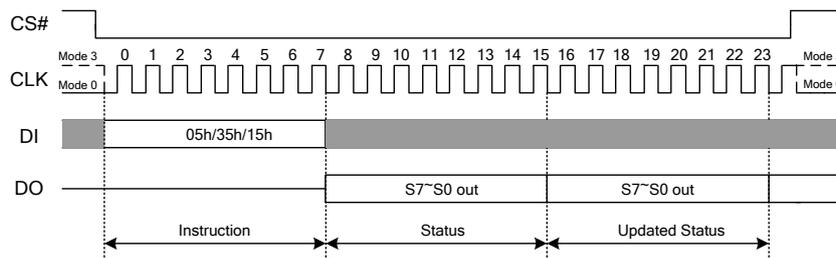


Figure 7.1a Read Status Register Instruction(SPI Mode)

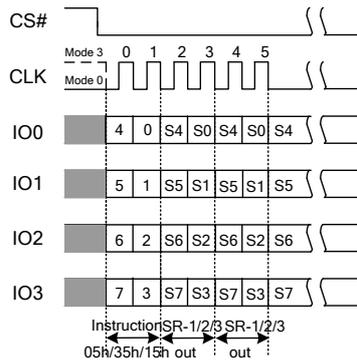


Figure 7.1b Read Status Register Instruction(QPI Mode)

### 7.1.2 Write Enable (06h)

The Write Enable instruction (Figure 7.2) sets the Write Enable Latch (WEL) bit in the Status Register to a 1. The WEL bit must be set prior to every Page Program, Sector Erase, Block Erase, Chip Erase and Write Status Register instruction. The Write Enable instruction is entered by driving CS# low, shifting the instruction code “06h” into the Data Input (DI) pin on the rising edge of CLK, and then driving CS# high.

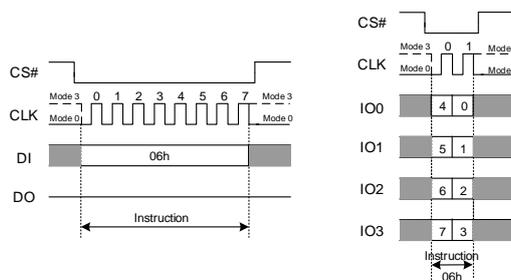


Figure 7.2 Write Enable Instruction(SPI or QPI Mode)

### 7.1.3 Write Enable for Volatile Status Register (50h)

The non-volatile Status Register bits described in section 6.2 can also be written to as volatile bits. This gives more flexibility to change the system configuration and memory protection schemes quickly without waiting for the typical non-volatile bit write cycles or affecting the endurance of the Status Register non-volatile bits. To write the volatile values into the Status Register bits, the Write Enable for Volatile Status Register (50h) instruction must be issued prior to a Write Status Register (01h) instruction. Write Enable for Volatile Status Register instruction (Figure 7.3) will not set the Write Enable Latch (WEL) bit, it is only valid for the Write Status Register instruction to change the volatile Status Register bit values.

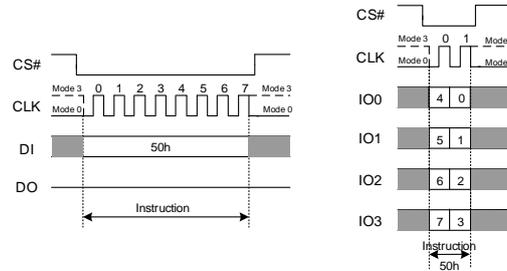


Figure 7.3 Write Enable for Volatile Status Register Instruction(SPI or QPI Mode)

### 7.1.4 Write Disable (04h)

The Write Disable instruction (Figure 7.4) resets the Write Enable Latch (WEL) bit in the Status Register to a 0. The Write Disable instruction is entered by driving CS# low, shifting the instruction code “04h” into the DI pin and then driving CS# high. Note that the WEL bit is automatically reset after Power-up and upon completion of the Write Status Register, Page Program, Sector Erase, Block Erase and Chip Erase instructions.

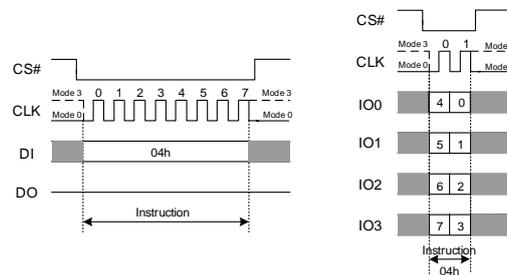


Figure 7.4 Write Disable Instruction(SPI or QPI Mode)

### 7.1.5 Write Status Register (01h/31h/11h)

The Write Status Registers command allows the Status Registers to be written. Only non-volatile Status Register bits SRP0, SEC, TB, BP2, BP1, BP0 (SR1[7:2]) CMP, LB3, LB2, LB1, QE, SRP1 (SR2[6:0]), and the volatile bits SR3[6:0] can be written. All other Status Register bit locations are read-only and will not be affected by the Write Status Registers command. LB[3:0] are non-volatile OTP bits; once each is set to 1, it cannot be cleared to 0. The Status Register bits are shown in Section 6.2, Status Registers. Any reserved bits should only be written to their default value.

To write non-volatile Status Register bits, a standard Write Enable (06h) command must previously have been executed for the device to accept the Write Status Registers Command (Status Register bit WEL must equal 1). Once write enabled, the command is entered by driving CS# low, sending the instruction code “01h”, and then writing the Status Register data bytes as illustrated in Figure 7.5.

To write volatile Status Register bits, a Write Enable for Volatile Status Register (50h) command must have been executed prior to the Write Status Registers command (Status Register bit WEL remains 0). However, SRP1 and LB3, LB2, LB1, LB0 cannot be changed because of the OTP protection for these bits. Upon power-off, the volatile Status Register bit values will be lost, and the non-volatile Status Register bit

values will be restored when power on again.

To complete the Write Status Registers command, the CS# pin must be driven high after the eighth bit of a data value is clocked in (CS# must be driven high on an 8-bit boundary). If this is not done the Write Status Registers command will not be executed.

The Write Status Register instruction allows the Status Register to be written. A Write Enable instruction must previously have been executed for the device to accept the Write Status Register Instruction (Status Register bit WEL must equal to 1). Once write enabled, the instruction is entered by driving CS# low, sending the instruction code “01h”, and then writing the status register data byte as illustrated in Figure 7.5.

During non-volatile Status Register write operation (06h combined with 01h/31h), after CS# is driven high, the self-timed Write Status Register cycle will commence for a time duration of  $t_W$  (See AC Characteristics). While the Write Status Register cycle is in progress, the Read Status Register instruction may still be accessed to check the status of the BUSY bit. The BUSY bit is a 1 during the Write Status Register cycle and a 0 when the cycle is finished and ready to accept other instructions again. After the Write Status Register cycle has finished, the Write Enable Latch (WEL) bit in the Status Register will be cleared to 0.

During volatile Status Register write operation (50h combined with 01h/31h/11h), after CS# is driven high, the Status Register bits will be refreshed to the new values within the time period of  $t_{SHSL2}$  (See AC Characteristics). BUSY bit will remain 0 during the Status Register bit refresh period.

If CS# is driven high after the eighth clock, the Write Status Register-1 (01h) instruction will only program the Status Register-1, the Status Register-2 will not be affected.

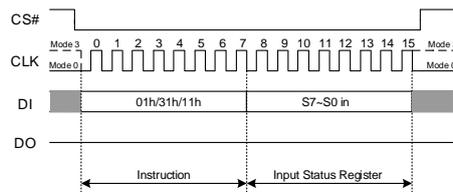


Figure 7.5a Write Status Register Instruction(SPI Mode)

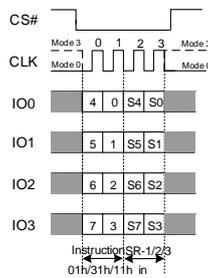


Figure 7.5b Write Status Register Instruction(QPI Mode)

## 7.2 Program and Erase Commands

### 7.2.1 Page Program (PP) (02h)

The Page Program instruction allows up to 256 bytes of data to be programmed at previously erased to all 1s (FFh) memory locations. A Write Enable instruction must be executed before the device will accept the Page Program Instruction (Status Register bit WEL must equal 1). The instruction is initiated by driving the CS# pin low then shifting the instruction code “02h” followed by a 24-bit address (A23-A0) and at least one data byte, into the DI pin. The CS# pin must be held low for the entire length of the instruction while data is being sent to the device. The Page Program instruction sequence is shown in Figure 7.6.

If an entire 256 byte page is to be programmed, the last address byte (the 8 least significant address bits) should be set to 0. If the last address byte is not zero, and the number of clocks exceeds the remaining page length, the addressing will wrap to the beginning of the page. In some cases, less than 256 bytes (a partial page) can be programmed without having any effect on other bytes within the same page. One condition to

perform a partial page program is that the number of clocks cannot exceed the remaining page length. If more than 256 bytes are sent to the device the addressing will wrap to the beginning of the page and overwrite previously sent data.

As with the write and erase instructions, the CS# pin must be driven high after the eighth bit of the last byte has been latched. If this is not done the Page Program instruction will not be executed. After CS# is driven high, the self-timed Page Program instruction will commence for a time duration of  $t_{pp}$  (See AC Characteristics). While the Page Program cycle is in progress, the Read Status Register instruction may still be accessed for checking the status of the BUSY bit. The BUSY bit is a 1 during the Page Program cycle and becomes a 0 when the cycle is finished and the device is ready to accept other instructions again. After the Page Program cycle has finished the Write Enable Latch (WEL) bit in the Status Register is cleared to 0. The Page Program instruction will not be executed if the addressed page is protected by the Block Protect (TB, SEC, BP2, BP1, and BP0) bits (see Status Register Memory Protection table).

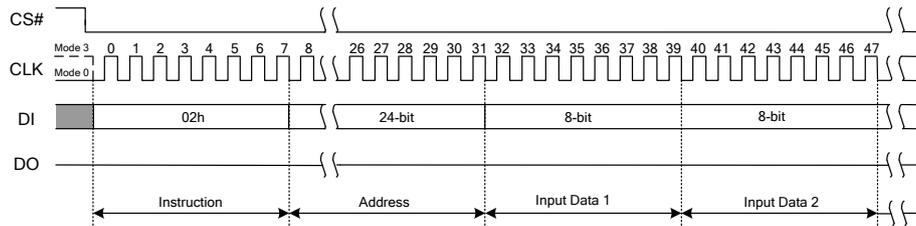


Figure 7.6a Page Program Instruction (SPI Mode)

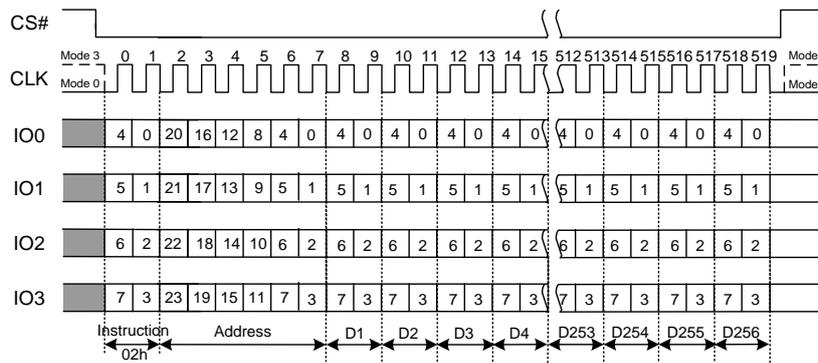


Figure 7.6b Page Program Instruction(QPI Mode)

### 7.2.2 Quad Input Page Program (32h)

The Quad Input Page Program instruction allows up to 256 byte of data to be programmed at previously erased (FFh) memory locations using four pins: IO0, IO1, IO2 and IO3. The Quad Input Page Program can improved performance for PROM Programmer and applications that have slow clock speeds < 5MHz. Systems with faster clock speed will not realize much benefit for the Quad Input Page Program instruction since the inherent page program time is much greater than the time it take to clock-in the data.

To use Quad Page Program the Quad Enable in Status Register-2 must be set (QE=1). A Write Enable instruction must be executed before the device will accept the Quad Page Program instruction (Status Register-1, WEL=1). The instruction is initiated by driving the CS# pin low then shifting the instruction code "32h" followed by a 24-bit address (A23-0) and at least one data byte, into the IO pins. The CS# pin must be held low for entire length of the instruction while data is being sent to the device. All other functions of Quad Page Program are identical to standard Page Program. The Quad Page Program instructions sequence is shown in Figure 7.7.

Note: 32h mode3 definition not compatible to others, contact XMC for details.

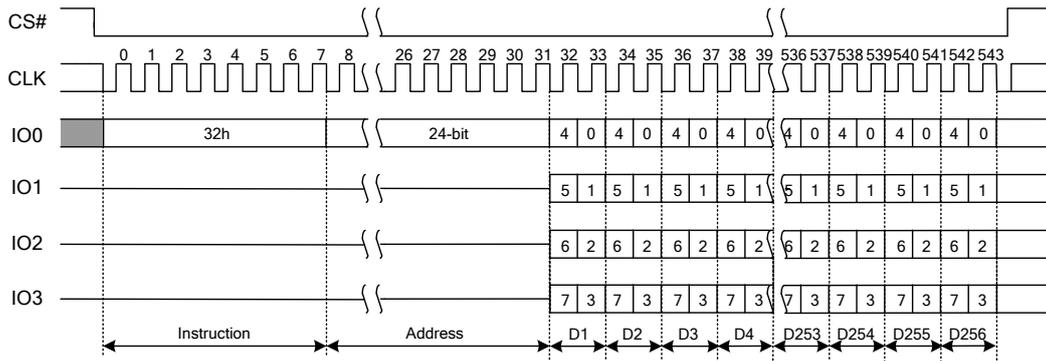


Figure 7.7 Quad Page Program Instruction

**7.2.3 Sector Erase (SE) (20h)**

The Sector Erase instruction sets all memory within a specified sector (4K-bytes) to the erased state of all 1s (FFh). A Write Enable instruction must be executed before the device will accept the Sector Erase Instruction (Status Register bit WEL must equal 1). The instruction is initiated by driving the CS# pin low and shifting the instruction code “20h” followed a 24-bit sector address (A23-A0). The Sector Erase instruction sequence is shown in Figure 7.8.

The CS# pin must be driven high after the eighth bit of the last byte has been latched. If this is not done the Sector Erase instruction will not be executed. After CS# is driven high, the self-timed Sector Erase instruction will commence for a time duration of  $t_{SE}$  (See AC Characteristics). While the Sector Erase cycle is in progress, the Read Status Register instruction may still be accessed for checking the status of the BUSY bit. The BUSY bit is a 1 during the Sector Erase cycle and becomes a 0 when the cycle is finished and the device is ready to accept other instructions again. After the Sector Erase cycle has finished the Write Enable Latch (WEL) bit in the Status Register is cleared to 0. The Sector Erase instruction will not be executed if the addressed page is protected by the Block Protect (TB, SEC, BP2, BP1, and BP0) bits (see Status Register Memory Protection table).

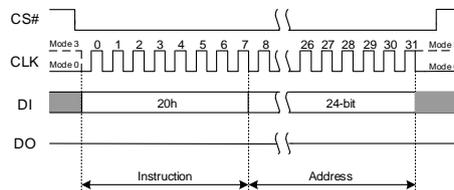


Figure 7.8a Sector Erase Instruction(SPI Mode)

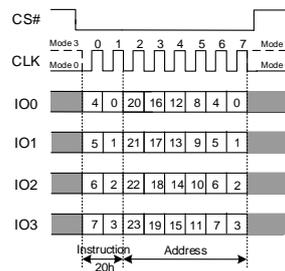


Figure 7.8b Sector Erase Instruction(QPI Mode)

**7.2.4 Block Erase (BE) (D8h) and Half Block Erase (52h)**

The Block Erase instruction sets all memory within a specified block (64K-bytes) or half block (32K- bytes) to the erased state of all 1s (FFh). A Write Enable instruction must be executed before the device will accept the Block Erase Instruction (Status Register bit WEL must equal 1). The instruction is initiated by driving the CS# pin low and shifting the instruction code “D8h” or “52h” followed a 24-bit block address (A23-A0). The Block Erase instruction sequence is shown in Figure 7.9.

The CS# pin must be driven high after the eighth bit of the last byte has been latched. If this is not done the Block Erase instruction will not be executed. After CS# is driven high, the self-timed Block Erase instruction will commence for a time duration of  $t_{BE}$  (See AC Characteristics). While the Block Erase cycle is in progress, the Read Status Register instruction may still be accessed for checking the status of the BUSY bit. The BUSY bit is a 1 during the Block Erase cycle and becomes a 0 when the cycle is finished and the device is ready to accept other instructions again. After the Block Erase cycle has finished the Write Enable Latch (WEL) bit in the Status Register is cleared to 0. The Block Erase instruction will not be executed if the addressed page is protected by the Block Protect (TB, SEC, BP2, BP1, and BP0) bits (see Status Register Memory Protection table).

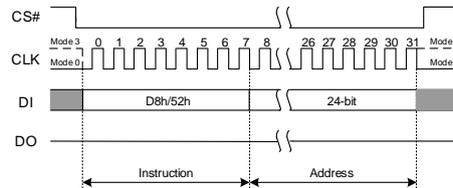


Figure 7.9a Block Erase Instruction(SPI Mode)

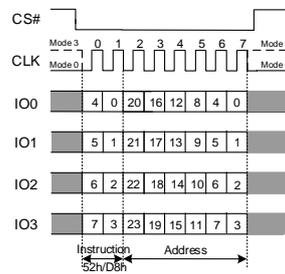


Figure 7.9b Block Erase Instruction(QPI Mode)

### 7.2.5 Chip Erase (CE) (C7h or 60h)

The Chip Erase instruction sets all memory within the device to the erased state of all 1s (FFh). A Write Enable instruction must be executed before the device will accept the Chip Erase Instruction (Status Register bit WEL must equal 1). The instruction is initiated by driving the CS# pin low and shifting the instruction code “C7h” or “60h”. The Chip Erase instruction sequence is shown in Figure 7.10.

The CS# pin must be driven high after the eighth bit has been latched. If this is not done the Chip Erase instruction will not be executed. After CS# is driven high, the self-timed Chip Erase instruction will commence for a time duration of  $t_{CE}$  (See AC Characteristics). While the Chip Erase cycle is in progress, the Read Status Register instruction may still be accessed to check the status of the BUSY bit. The BUSY bit is a 1 during the Chip Erase cycle and becomes a 0 when finished and the device is ready to accept other instructions again. After the Chip Erase cycle has finished the Write Enable Latch (WEL) bit in the Status Register is cleared to 0. The Chip Erase instruction will not be executed if any page is protected by the Block Protect (SEC, TB, BP2, BP1, and BP0) bits (see Status Register Memory Protection table).

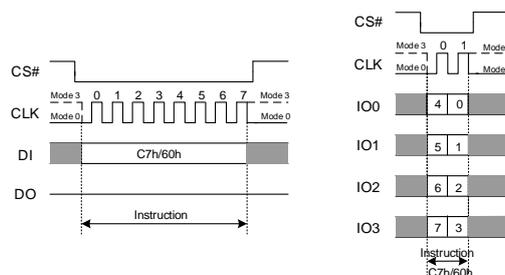


Figure 7.10 Chip Erase Instruction(SPI or QPI Mode)

**7.2.6 Erase / Program Suspend (75h)**

The Erase / Program Suspend command allows the system to interrupt a Sector or Block Erase operation, then read from or program data to any other sector. The Erase / Program Suspend command also allows the system to interrupt a Page Program operation and then read from any other page or erase any other sector or block. The Erase / Program Suspend command sequence is shown in Figure 7.11.

The Write Status Registers command (01h, 31h), and Erase commands (20h, 52h, D8h, C7h, 60h, 44h) are not allowed during Erase Suspend. Erase Suspend is valid only during the Sector or Block erase operation. If written during the Chip Erase operation, the Erase Suspend command is ignored. The Write Status Registers command (01h, 31h), and Program commands (02h, 32h, 42h) are not allowed during Program Suspend. Program Suspend is valid during the Page Program or Quad Page Program operation.

The Erase / Program Suspend command 75h will be accepted by the device only if the SUS bit in the Status Register equals to 0 and the BUSY bit equals to 1 while a Sector or Block Erase or a Page Program operation is on-going. If the SUS bit equals to 1 or the BUSY bit equals to 0, the Suspend command will be ignored by the device. Program or Erase command for the sector that is being suspended will be ignored.

A maximum of time of  $t_{SUS}$  (Section 8.5, AC Electrical Characteristics) is required to suspend the erase or program operation. The BUSY bit in the Status Register will be cleared from 1 to 0 within  $t_{SUS}$  and the SUS bit in the Status Register will be set from 0 to 1 immediately after Erase/Program Suspend. For a previously resumed Erase/Program operation, it is also required that the Suspend command 75h is not issued earlier than a minimum of time of  $t_{SUS}$  following the preceding Resume command 7Ah.

Unexpected power off during the Erase / Program suspend state will reset the device and release the suspend state. SUS bit in the Status Register will also reset to 0. The data within the page, sector or block that was being suspended may become corrupted. It is recommended for the user to implement system design techniques to prevent accidental power interruption, provide non-volatile tracking of in process program or erase commands, and preserve data integrity by evaluating the non-volatile program or erase tracking information during each system power up in order to identify and repair (re-erase and re-program) any improperly terminated program or erase operations.

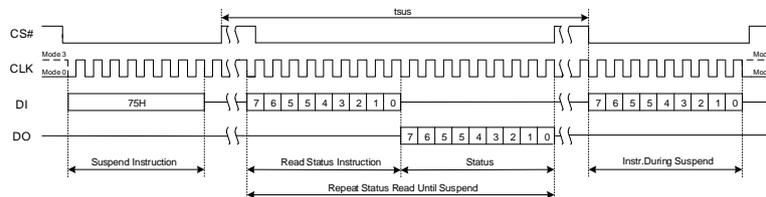


Figure 7.11a Erase / Program Suspend Instruction(SPI Mode)

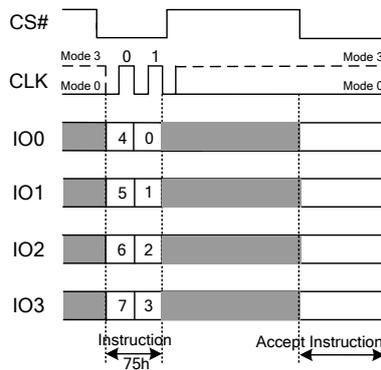


Figure 7.11b Erase / Program Suspend Instruction(QPI Mode)

**7.2.7 Erase / Program Resume (7Ah)**

The Erase / Program Resume command “7Ah” must be written to resume the Sector or Block Erase

operation or the Page Program operation after an Erase / Program Suspend. The Resume command “7Ah” will be accepted by the device only if the SUS bit in the Status Register equals to 1 and the BUSY bit equals to 0. After the Resume command is issued the SUS bit will be cleared from 1 to 0 immediately, the BUSY bit will be set from 0 to 1 within 200 ns and the Sector or Block will complete the erase operation or the page will complete the program operation. If the SUS bit equals to 0 or the BUSY bit equals to 1, the Resume command “7Ah” will be ignored by the device. The Erase / Program Resume command sequence is shown in Figure 7.12. It is required that a subsequent Erase / Program Suspend command not to be issued within a minimum of time of “t<sub>SUS</sub>” following a Resume command.

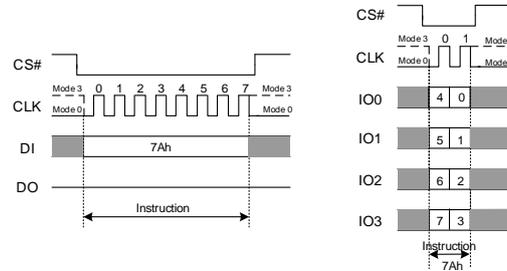


Figure 7.12 Erase/Program Resume Instruction(SPI or QPI Mode)

### 7.3 Read Commands

#### 7.3.1 Read Data (03h)

The Read Data instruction allows one more data bytes to be sequentially read from the memory. The instruction is initiated by driving the CS# pin low and then shifting the instruction code “03h” followed by a 24-bit address (A23-A0) into the DI pin. The code and address bits are latched on the rising edge of the CLK pin. After the address is received, the data byte of the addressed memory location will be shifted out on the DO pin at the falling edge of CLK with most significant bit (MSB) first. The address is automatically incremented to the next higher address after each byte of data is shifted out allowing for a continuous stream of data. This means that the entire memory can be accessed with a single instruction as long as the clock continues. The instruction is completed by driving CS# high.

The Read Data instruction sequence is shown in Figure 7.13. If a Read Data instruction is issued while an Erase, Program or Write cycle is in process (BUSY=1) the instruction is ignored and will not have any effects on the current cycle. The Read Data instruction allows clock rates from D.C. to a maximum of f<sub>R</sub> (see AC Electrical Characteristics).

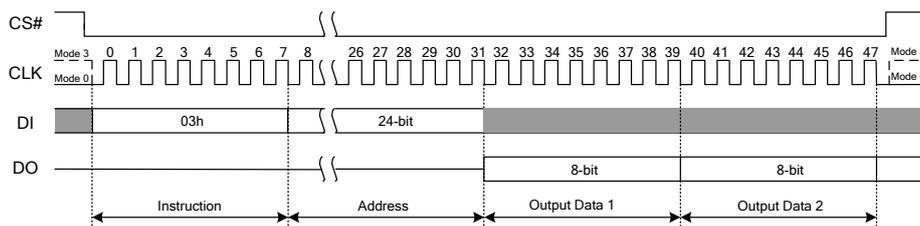


Figure 7.13 Read Data Instruction

#### 7.3.2 Fast Read (0Bh)

The Fast Read instruction is similar to the Read Data instruction except that it can operate at the highest possible frequency of F<sub>R</sub> (see AC Electrical Characteristics). This is accomplished by adding eight “dummy” clocks after the 24-bit address as shown in Figure 7.14. The dummy clocks allow the devices internal circuits additional time for setting up the initial address. During the dummy clocks the data value on the DI pin is a “don’t care”.

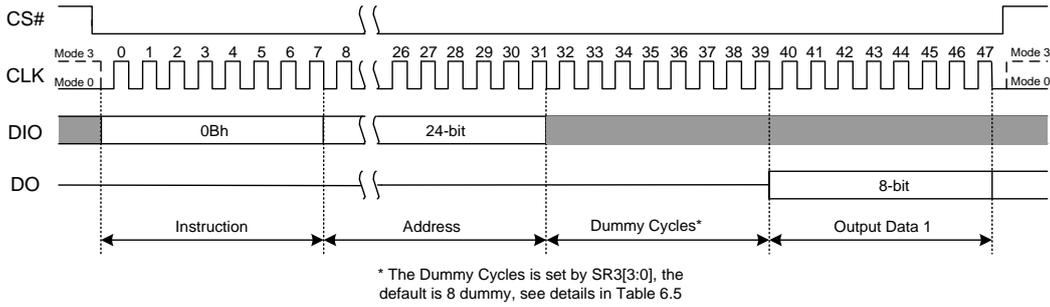


Figure 7.14a Fast Read Instruction (SPI Mode)

**Fast Read (0Bh) in QPI Mode**

The Fast Read instruction is also supported in QPI mode. When QPI mode is enabled, the number of dummy clocks is configured by the “Set Read Parameters (C0h)” instruction to accommodate a wide range of applications with different needs for either maximum Fast Read frequency or minimum data access latency. Depending on the Read Parameter Bits P[5:4] setting, the number of dummy clocks can be configured as either 2, 4, 6 or 8. The default number of dummy clocks upon power up or after a Reset instruction is 2.

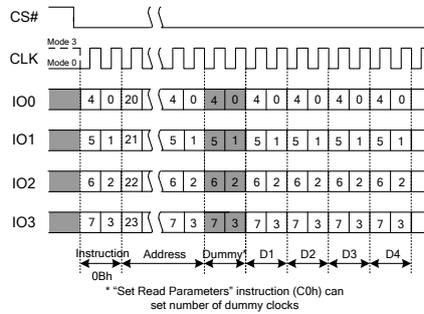


Figure 7.14b Fast Read Instruction (QPI Mode)

**7.3.3 Fast Read Dual Output (3Bh)**

The Fast Read Dual Output (3Bh) instruction is similar to the standard Fast Read (0Bh) instruction except that data is output on two pins, DO and DI, instead of just DO. This allows data to be transferred from the XM25QH32B at twice the rate of standard SPI devices. The Fast Read Dual Output instruction is ideal for quickly downloading code from Flash to RAM upon power-up or for applications that cache code-segments to RAM for execution.

Similar to the Fast Read instruction, the Fast Read Dual Output instruction can operate at the highest possible frequency of  $F_R$  (see AC Electrical Characteristics). This is accomplished by adding eight “dummy” clocks after the 24-bit address as shown in Figure 7.15. The dummy clocks allow the device's internal circuits additional time for setting up the initial address. The input data during the dummy clocks is “don't care”. However, the DI pin should be high-impedance prior to the falling edge of the first data out clock.

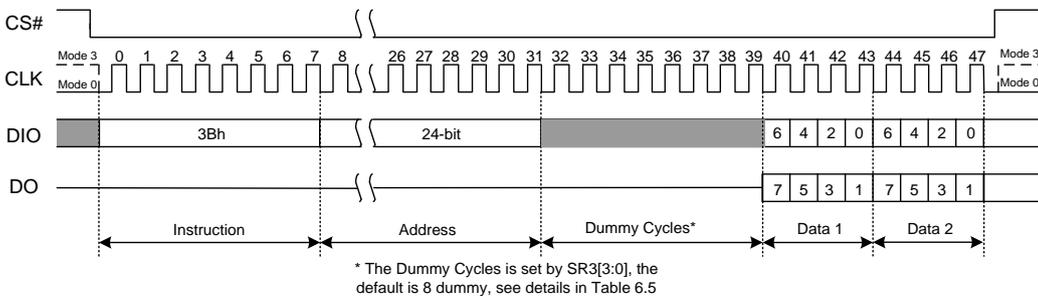


Figure 7.15 Fast Read Dual Output Instruction Sequence Diagram

### 7.3.4 Fast Read Quad Output (6Bh)

The Fast Read Quad Output (6Bh) instruction is similar to the Fast Dual Output (3Bh) instruction except that data is output on four pins, IO0, IO1, IO2 and IO3. A Quad enable of status Register-2 must be executed before the device will accept the Fast Read Quad Output Instruction (Status Register bit QE must equal 1). The Fast Read Quad Output Instruction allows data to be transferred from XM25QH32B at four times the rate of standard SPI devices.

The Fast Read Quad Output instruction can operate at the highest possible frequency of  $F_R$  (see AC Electrical Characteristics). This is accomplished by adding "dummy" clocks after the 24-bit address as shown in Figure 7.16. The input data during the dummy clocks is "don't care". However, the IO pins should be high-impedance prior to the falling edge of the first data out clock.

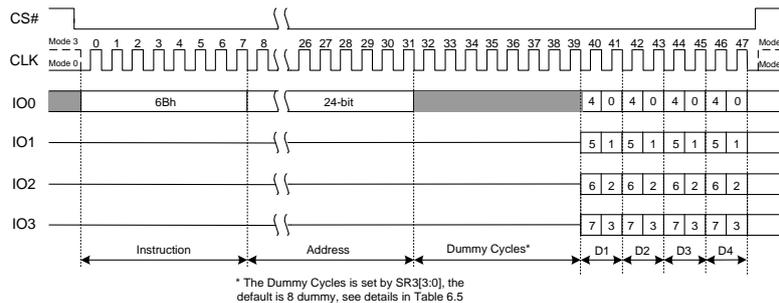


Figure 7.16 Fast Read Quad Output Instruction

### 7.3.5 Fast Read Dual I/O (BBh)

The Fast Read Dual I/O (BBh) instruction allows for improved random access while maintaining two IO pins, IO0 and IO1. It is similar to the Fast Read Dual Output (3Bh) instruction but with the capability to input the Address bits (A23-0) two bits per clock. This reduced instruction overhead may allow for code execution (XIP) directly from the Dual SPI in some applications.

#### Fast Read Dual I/O with "Continuous Read Mode"

The Fast Read Dual I/O instruction can further reduce instruction overhead through setting the "Continuous Read Mode" bits (M7-0) after the input Address bits (A23-0), as shown in Figure 7.17. The upper nibble of the (M7-4) controls the length of the next Fast Read Dual I/O instruction through the inclusion or exclusion of the first byte instruction code. The lower nibble bits of the (M3-0) are don't care ("X"). However, the IO pins should be high-impedance prior to the falling edge of the first data out clock. It is recommended to input FFFFh on IO0 for the next instruction (16 clocks), to ensure M4 = 1 and return the device to normal operation.

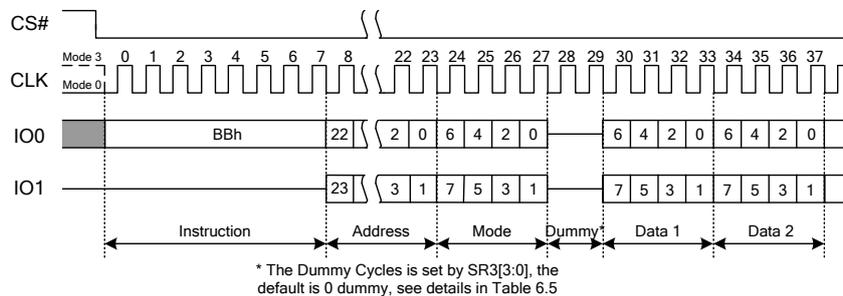


Figure 7.17 Fast Read Dual I/O Instruction (Initial command or previous M5-4≠10)

**Note:**

1. Least significant 4 bits of Mode are don't care and it is optional for the host to drive these bits. The host may turn off drive during these cycles to increase bus turnaround time between Mode bits from host and returning data from the memory

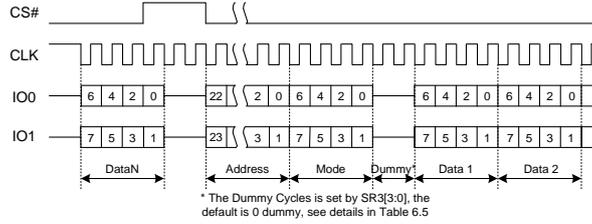


Figure 7.18 Fast Read Dual I/O Instruction (Initial command or previous M5-4=10)

### 7.3.6 Fast Read Quad I/O (EBh)

The Fast Read Quad I/O (EBh) command is similar to the Fast Read Dual I/O (BBh) command except that address and data bits are input and output through four pins IO0, IO1, IO2 and IO3 and Dummy clock are required prior to the data output. The Quad I/O dramatically reduces instruction overhead allowing faster random access for code execution (XIP) directly from the Quad SPI. The Quad Enable bit (QE) of Status Register-2 must be set to enable the Fast Read Quad I/O Command.

#### Fast Read Quad I/O with “Continuous Read Mode”

The Fast Read Quad I/O command can further reduce instruction overhead through setting the “Continuous Read Mode” bits (M7-0) after the input Address bits (A23-0), as shown in Figure 7.19, Fast Read Quad I/O Command Sequence (Initial command or previous M5-4≠10). The upper nibble of the (M7-4) controls the length of the next Fast Read Quad I/O command through the inclusion or exclusion of the first byte instruction code. The lower nibble bits of the (M3-0) are don't care (“X”). However, the IO pins should be high-impedance prior to the falling edge of the first data out clock.

If the “Continuous Read Mode” bits M5-4 = (1,0), then the next Fast Read Quad I/O command (after CS# is raised and then lowered) does not require the EBh instruction code, as shown in Figure 7.20, Fast Read Quad I/O Command Sequence (Previous command set M5-4 = 10). This reduces the command sequence by eight clocks and allows the Read address to be immediately entered after CS# is asserted low. If the “Continuous Read Mode” bits M5-4 do not equal to (1, 0), the next command (after CS# is raised and then lowered) requires the first byte instruction code, thus returning to normal operation. It is recommended to input FFh on IO0 for the next instruction (8 clocks), to ensure M4=1 and return the device to normal operation.

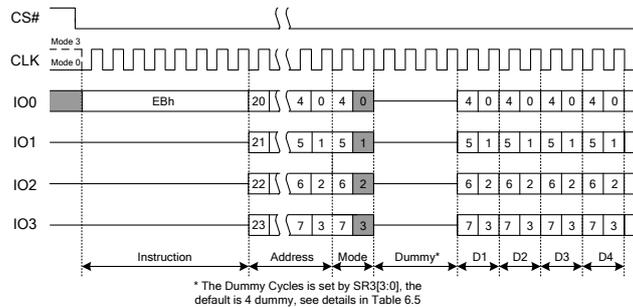


Figure 7.19a Fast Read Quad I/O Instruction(Initial command or previous M5-4 ≠10)

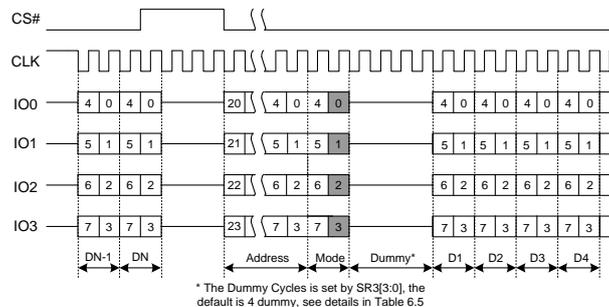


Figure 7.20 Fast Read Quad I/O Instruction(Previous command set M5-4 = 10)

**Fast Read Quad I/O with “8/16/32/64-Byte Wrap Around”**

The Fast Read Quad I/O command can also be used to access a specific portion within a page by issuing a “Set Burst with Wrap” command prior to EBh. The “Set Burst with Wrap” command can either enable or disable the “Wrap Around” feature for the following EBh commands. When “Wrap Around” is enabled, the data being accessed can be limited to 8/16/32/64-byte section of data. The output data starts at the initial address specified in the command, once it reaches the ending boundary of the 8/16/32/64-byte section, the output will wrap around to the beginning boundary automatically until CS# is pulled high to terminate the command.

The Burst with Wrap feature allows applications that use cache to quickly fetch a critical address and then fill the cache afterwards within a fixed length (8/16/32/64-bytes) of data without issuing multiple read commands.

The “Set Burst with Wrap” command allows three “Wrap Bits”, W6-4 to be set. The W4 bit is used to enable or disable the “Wrap Around” operation while W6-5 is used to specify the length of the wrap around section within a page. See Section 7.3.9, Set Burst with Wrap (77h).

**Fast Read Quad I/O (EBh) in QPI Mode**

The Fast Read Quad I/O instruction is also supported in QPI mode, as shown in Figure 7.19b. When QPI mode is enabled, the number of dummy clocks is configured by the “Set Read Parameters (C0h)” instruction to accommodate a wide range of applications with different needs for either maximum Fast Read frequency or minimum data access latency. Depending on the Read Parameter Bits P[5:4] setting, the number of dummy clocks can be configured as either 2, 4, 6 or 8. The default number of dummy clocks upon power up or after a Reset instruction is 2. In QPI mode, the “Continuous Read Mode” bits M7-0 are also considered as dummy clocks. In the default setting, the data output will follow the Continuous Read Mode bits immediately.

“Continuous Read Mode” feature is also available in QPI mode for Fast Read Quad I/O instruction. Please refer to the description on previous pages.

“Wrap Around” feature is not available in QPI mode for Fast Read Quad I/O instruction. To perform a read operation with fixed data length wrap around in QPI mode, a dedicated “Burst Read with Wrap” (0Ch) instruction must be used. Please refer to 7.5.13 for details.

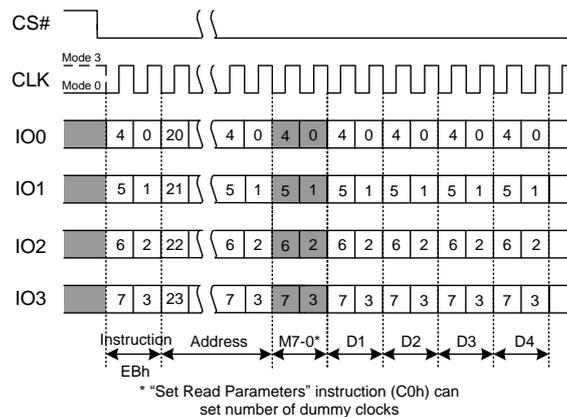


Figure 7.19b Fast Read Quad I/O Instruction(Initial command or previous M5-4 ≠10,QPI Mode)

**7.3.7 Word Read Quad I/O (E7h)**

The Word Read Quad I/O (E7h) instruction is similar to the Fast Quad I/O (EBh) instruction except that the lowest Address bit (A0) must equal to 0 and only two Dummy clocks are required prior to the data output. The Quad I/O dramatically reduces instruction overhead allowing faster random access for code execution (XIP) directly from the Quad SPI. The Quad Enable bit (QE) of Status Register-2 must be set to enable the Word Read Quad I/O instruction.

**Word Read Quad I/O with "Continuous Read Mode"**

The Word Read Quad I/O instruction can further reduce instruction overhead through setting the "Continuous Read Mode" bits (M7-0) after the input Address bits (A23-0), as shown in Figure 7.21. The upper nibble of the (M7-4) controls the length of the next Fast Read Quad I/O instruction through the inclusion or exclusion of the first byte instruction code. The lower nibble bits of the (M3-0) are don't care ("X"). However, the IO pins should be high-impedance prior to the falling edge of the first data out clock.

If the "Continuous Read Mode" bits M5-4 = (1,0), then the next Fast Read Quad I/O instruction (after CS# is raised and then lowered) does not require the E7h instruction code, as shown in Figure 7.22. This reduces the instruction sequence by eight clocks and allows the read address to be immediately entered after CS# is asserted low. The "Continuous Read Mode Reset" instruction is also able to reset M7-0 before issuing normal instructions.

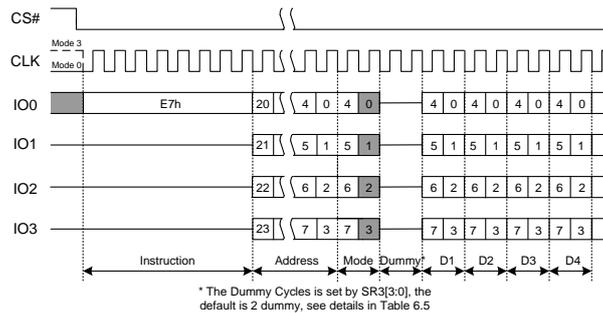


Figure 7.21 Word Read Quad I/O Instruction(Initial command or previous M5-4 ≠10)

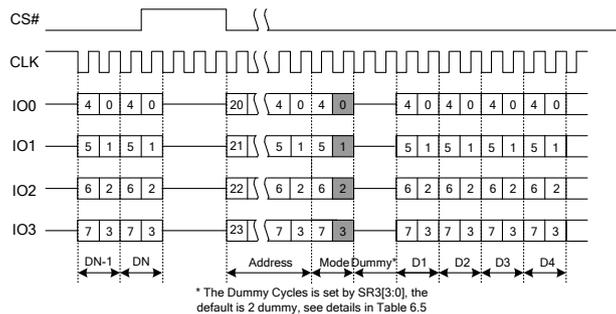


Figure 7.22 Word Read Quad I/O Instruction(Initial command or previous M5-4 =10)

**Word Read Quad I/O with "8/16/32/64-Byte Wrap Around" in Standard SPI mode**

The Word Read Quad I/O instruction can also be used to access a specific portion within a page by issuing a "Set Burst with Wrap" (77h) command prior to E7h. The "Set Burst with Wrap" (77h) command can either enable or disable the "Wrap Around" feature for the following E7h commands. When "Wrap Around" is enabled, the data being accessed can be limited to either an 8, 16, 32 or 64-byte section of a 256-byte page. The output data starts at the initial address specified in the instruction, once it reaches the ending boundary of the 8/16/32/64-byte section, the output will wrap around to the beginning boundary automatically until CS# is pulled high to terminate the command.

The Burst with Wrap feature allows applications that use cache to quickly fetch a critical address and then fill the cache afterwards within a fixed length (8/16/32/64-byte) of data without issuing multiple read commands.

The "Set Burst with Wrap" instruction allows three "Wrap Bits", W6-4 to be set. The W4 bit is used to enable or disable the "Wrap Around" operation while W6-5 are used to specify the length of the wrap around section within a page. See 7.3.9 for detail descriptions.

**7.3.8 Octal Word Read Quad I/O (E3h)**

The Octal Word Read Quad I/O (E3h) instruction is similar to the Fast Read Quad I/O (EBh) instruction except that the lower four Address bits (A0, A1, A2, A3) must equal 0. As a result, the dummy clocks are not required, which further reduces the instruction overhead allowing even faster random access for code execution (XIP). The Quad Enable bit (QE) of Status Register-2 must be set to enable the Octal Word Read Quad I/O Instruction.

**Octal Word Read Quad I/O with “Continuous Read Mode”**

The Octal Word Read Quad I/O instruction can further reduce instruction overhead through setting the “Continuous Read Mode” bits (M7-0) after the input Address bits (A23-0), as shown in Figure 7.23. The upper nibble of the (M7-4) controls the length of the next Octal Word Read Quad I/O instruction through the inclusion or exclusion of the first byte instruction code. The lower nibble bits of the (M3-0) are don't care (“x”). However, the IO pins should be high-impedance prior to the falling edge of the first data out clock.

If the “Continuous Read Mode” bits M5-4 = (1,0), then the next Fast Read Quad I/O instruction (after CS# is raised and then lowered) does not require the E3h instruction code, as shown in Figure 7.24. This reduces the instruction sequence by eight clocks and allows the Read address to be immediately entered after CS# is asserted low. If the “Continuous Read Mode” bits M5-4 do not equal to (1,0), the next instruction (after CS# is raised and then lowered) requires the first byte instruction code, thus returning to normal operation. It is recommended to input FFh on IO0 for the next instruction (8 clocks), to ensure M4= 1 and return the device to normal operation.

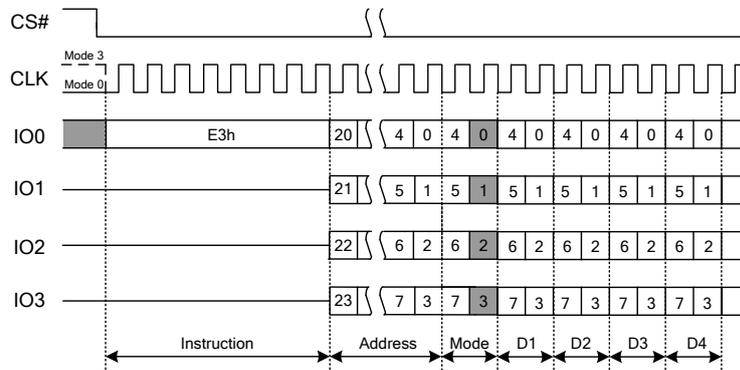


Figure 7.23 Octal Word Read Quad I/O Instruction(Initial command or previous M5-4 ≠10)

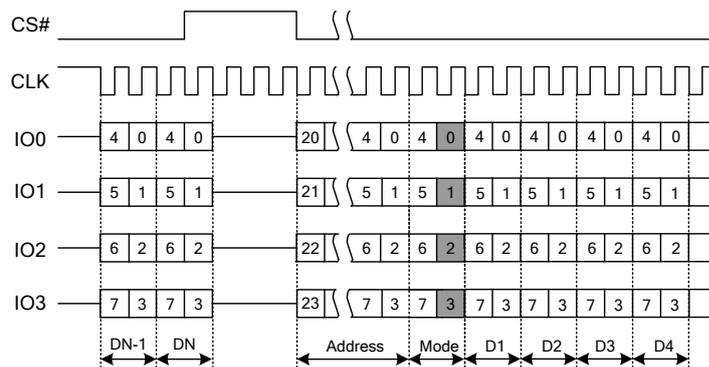


Figure 7.24 Octal Word Read Quad I/O Instruction(Initial command or previous M5-4 =10)

**7.3.9 Set Burst with Wrap (77h)**

The Set Burst with Wrap (77h) command is used in conjunction with “Fast Read Quad I/O” commands to access a fixed length and alignment of 8/16/32/64-bytes of data. Certain applications can benefit from this feature and improve the overall system code execution performance. This command loads the W4,W5,W6 bits. Similar to a Quad I/O command, the Set Burst with Wrap command is initiated by driving the CS# pin low and then shifting the instruction code “77h” followed by 24-dummy bits and 8 “Wrap Bits”, W7-0. The

command sequence is shown in Figure 7.25, Set Burst with Wrap Command Sequence. Wrap bit W7 and the lower nibble W3-0 are not used.

W6, W5	W4=0		W4=1(DEFAULT)	
	Wrap Around	Wrap Length	Wrap Around	Wrap Length
0,0	Yes	8-byte	No	N/A
0,1	Yes	16-byte	No	N/A
1,0	Yes	32-byte	No	N/A
1,1	Yes	64-byte	No	N/A

Once W6-4 is set by a Set Burst with Wrap command, all the following “Fast Read Quad I/O” commands will use the W6-4 setting to access the 8/16/32/64-byte section of data. Note, Status Register-2 QE bit (SR2[1]) must be set to 1 in order to use the Fast Read Quad I/O and Set Burst with Wrap commands. To exit the “Wrap Around” function and return to normal read operation, another Set Burst with Wrap command should be issued to set W4 = 1. The default value of W4 upon power on is 1.

In QPI mode, the “Burst Read with Wrap (0Ch)” instruction should be used to perform the Read operation with “Wrap Around” feature. The Wrap Length set by W6-5 in Standard SPI mode is still valid in QPI mode and can also be re-configured by “Set Read Parameters (C0h)” instruction. Refer to 7.5.12 and 7.5.13 for details.

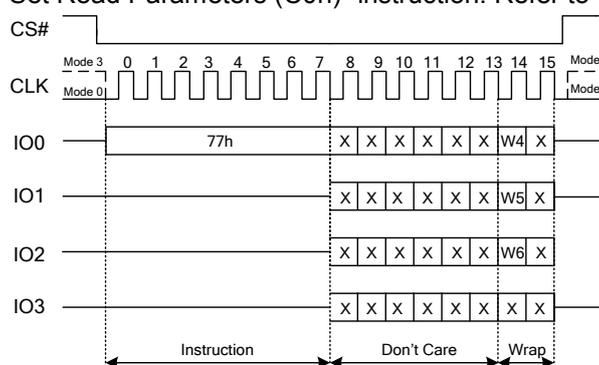


Figure 7.25 Set Burst with Wrap Instruction

## 7.4 Reset Commands

Software controlled Reset commands restore the device to its initial power up state, by reloading volatile registers from non-volatile default values. If a software reset is initiated during a Erase, Program or Writing Register operation the data in that Sector, Page or Register is not stable, the operation that was interrupted needs to be initiated again. Once the Reset instruction is accepted, any on-going internal operations will be terminated and the device will return to its default power-on state and lose all the current volatile settings, such as Volatile Status Register bits, Write Enable Latch (WEL) status, Program/Erase Suspend status, Read parameter setting (P7-P0), Continuous Read Mode bit setting (M7-M0) and Wrap Bit setting (W6-W4).

When the device is in Deep Power-Down mode, the software reset command is ignored and has no effect. To reset the device send the Release Power down command (ABh) and after time duration of  $t_{RES1}$  the device will resume normal operation and the software reset command will be accepted.

A software reset is initiated by the Software Reset Enable command (66h) followed by Software Reset command (99h) and then executed when CS# is brought high after  $t_{RCH}$  time at the end of the Software Reset instruction and requires  $t_{RST}$  time before executing the next Instruction after the Software Reset. See Figure 8.7, Software Reset Input Timing. Note that CS# must be brought high after  $t_{RCH}$  time, or the Software Reset will not be executed.

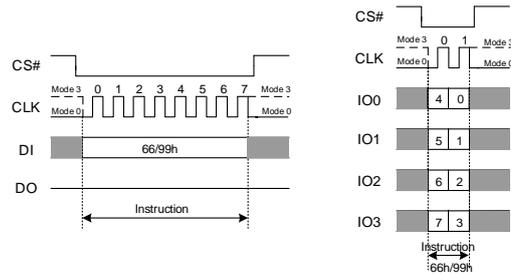


Figure 7.26 Software Reset Instruction(SPI and QPI Mode)

**7.4.1 Software Reset Enable (66h)**

The Reset Enable (66h) command is required immediately before a software reset command (99h) such that a software reset is a sequence of the two commands. Any command other than Reset (99h) following the Reset Enable (66h) command, will clear the reset enable condition and prevent a later Reset (99h) command from being recognized.

**7.4.2 Software Reset (99h)**

The Reset (99h) command immediately following a Reset Enable (66h) command, initiates the software reset process. Any command other than Reset (99h) following the Reset Enable (66h) command, will clear the reset enable condition and prevent a later Reset (99h) command from being recognized.

**7.5 ID and Security Commands**

**7.5.1 Deep Power-down (DP) (B9h)**

Although the standby current during normal operation is relatively low, standby current can be further reduced with the Power-down instruction. The lower power consumption makes the Power-down instruction especially useful for battery powered applications (See ICC1 and ICC2 in AC Characteristics). The instruction is initiated by driving the CS# pin low and shifting the instruction code “B9h” as shown in Figure 7.27.

The CS# pin must be driven high after the eighth bit has been latched. If this is not done, the Power-down instruction will not be executed. After CS# is driven high, the power-down state will enter within the time duration of  $t_{DP}$  (See AC Characteristics). While in the power-down state only the Release from Power-down / Device ID instruction, which restores the device to normal operation, will be recognized. All other instructions are ignored. This includes the Read Status Register instruction, which is always available during normal operation. Ignoring all but one instruction makes the Power Down state a useful condition for securing maximum write protection. The device always powers-up in the normal operation with the standby current of ICC1.

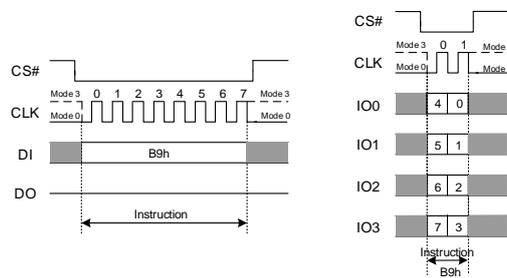


Figure 7.27 Deep Power-down Instruction(SPI and QPI Mode)

**7.5.2 Release Power-down / Device ID (ABh)**

The Release from Power-down / Device ID instruction is a multi-purpose instruction. It can be used to release the device from the power-down state, obtain the devices electronic identification (ID) number or both.

To release the device from the power-down state, the instruction is issued by driving the CS# pin low, shifting the instruction code “ABh” and driving CS# high as shown in Figure 7.28. After the time duration of  $t_{RES1}$  (See AC Characteristics) the device will resume normal operation and other instructions will be accepted. The CS# pin must remain high during the  $t_{RES1}$  time duration.

When used only to obtain the Device ID during the non-power-down state, the instruction is initiated by driving the CS# pin low and shifting the instruction code “ABh” followed by 3-dummy bytes. The Device ID bits will then be shifted out on the falling edge of CLK with most significant bit (MSB) first as shown in Figure 7.29. The Device ID value for the XM25QH32B is listed in Manufacturer and Device Identification table. The Device ID can be read continuously. The instruction is completed by driving CS# high.

When used to release the device from the power-down state and obtain the Device ID, the instruction is the same as previously described, and shown in Figure 7.29, except that after CS# is driven high it must remain high for a time duration of  $t_{RES2}$  (See AC Characteristics). After this time duration the device will resume normal operation and other instructions will be accepted. If the Release from Power-down / Device ID instruction is issued within Erase, Program or Write cycle (when BUSY equals 1), the instruction is ignored and will not have any effects on the current cycle.

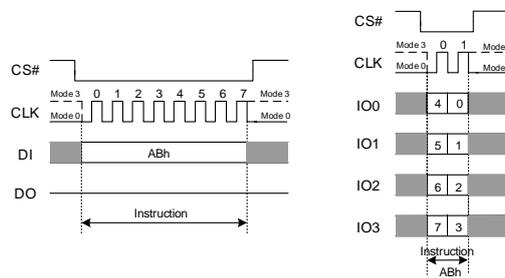


Figure 7.28 Release Power-down Instruction(SPI and QPI Mode)

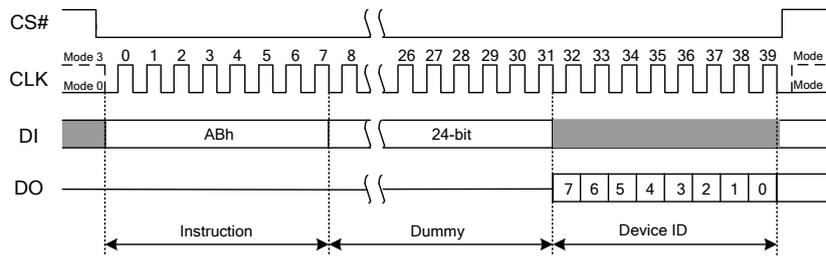


Figure 7.29a Release Power-down / Device ID(SPI Mode)

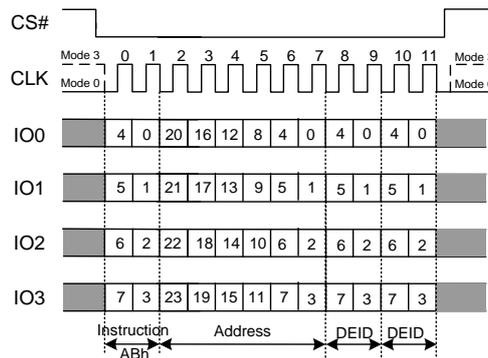


Figure 7.29b Release Power-down / Device ID(QPI Mode)

### 7.5.3 Read Manufacturer / Device ID (90h)

The Read Manufacturer/Device ID instruction is an alternative to the Release from Power-down/Device ID instruction that provides both the JEDEC assigned manufacturer ID and the specific device ID.

The Read Manufacturer/Device ID instruction is very similar to the Release from Power-down / Device ID instruction. The instruction is initiated by driving the CS# pin low and shifting the instruction code “90h” followed by a 24-bit address (A23-A0) of 000000h. After which, the Manufacturer ID and the Device ID are shifted out on the falling edge of CLK with most significant bit (MSB) first as shown in Figure 7.30. If the 24-bit address is initially set to 000001h the Device ID will be read first and then followed by the Manufacturer ID. The Manufacturer and Device IDs can be read continuously, alternating from one to the other. The command is completed by driving CS# high.

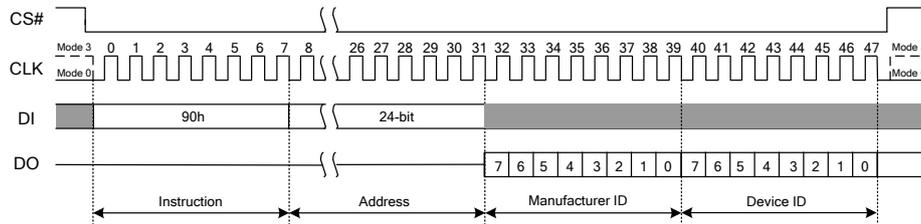


Figure 7.30a Read Manufacturer/Device ID(SPI Mode)

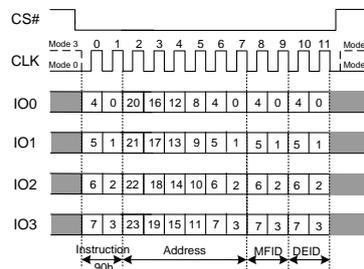


Figure 7.30b Read Manufacturer/Device ID(QPI Mode)

### 7.5.4 Read Identification (RDID) (9Fh)

For compatibility reasons, the XM25QH32B provides several instructions to electronically determine the identity of the device. The Read JEDEC ID instruction is compatible with the JEDEC standard for SPI compatible serial memories that was adopted in 2003.

The instruction is initiated by driving the CS# pin low and shifting the instruction code “9Fh”. The JEDEC assigned Manufacturer ID byte and two Device ID bytes, Memory Type (ID15-ID8) and Capacity (ID7-ID0) are then shifted out on the falling edge of CLK with most significant bit (MSB) first as shown in Figure 7.31. For memory type and capacity values, refer to Manufacturer and Device Identification table.

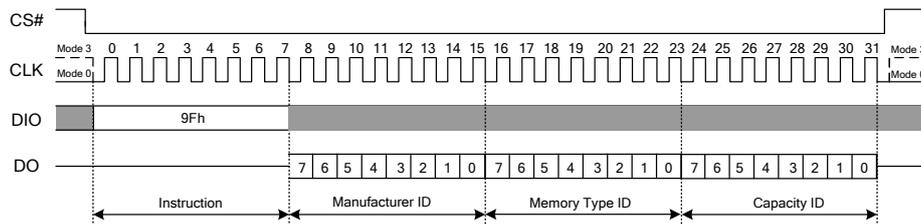


Figure 7.31a Read JEDEC ID(SPI Mode)

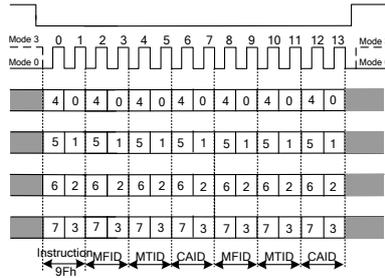


Figure 7.31b Read JEDEC ID(QPI Mode)

**7.5.5 Read SFDP Register (5Ah)**

The Read SFDP command is initiated by driving the CS# pin low and shifting the instruction code “5Ah” followed by a 24-bit address (A23-A0) into the DI pin. Eight “dummy” clocks are also required before the SFDP register contents are shifted out on the falling edge of the 40th CLK with most significant bit (MSB) first as shown in Figure 7.32.

**Note:** A23-A8 = 0; A7-A0 are used to define the starting byte address for the 256-byte SFDP Register.

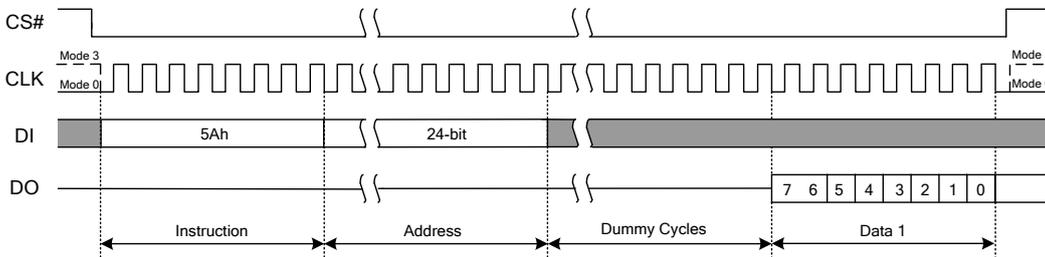


Figure 7.32 Read SFDP Register Instruction

**7.5.6 Erase Security Registers (44h)**

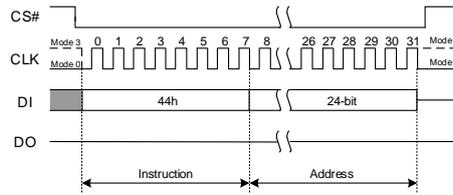
The XM25QH32B offers three 256-byte Security Registers which can be erased and programmed individually. These registers may be used by system manufacturers to store security and other important information separately from the main memory array.

The Erase Security Register command is similar to the Sector Erase command. A Write Enable command must be executed before the device will accept the Erase Security Register Command (Status Register bit WEL must equal to 1). The command is initiated by driving the CS# pin low and shifting the instruction code “44h” followed by a 24-bit address (A23-A0) to erase one of the security registers.

Address	A23-16	A15-8	A7-0
Security Register-1	00h	10h	xxh
Security Register-2	00h	20h	xxh
Security Register-3	00h	30h	xxh

**Note:**  
1. Addresses outside the ranges in the table have undefined results.

The Erase Security Register command sequence is shown in Figure 7.33. The CS# pin must be driven high after the eighth bit of the last byte has been latched. If this is not done the command will not be executed. After CS# is driven high, the self-timed Erase Security Register operation will commence for a time duration of t<sub>SE</sub> (see Section 8.5, AC Electrical Characteristics). While the Erase Security Register cycle is in progress, the Read Status Register command may still be accessed for checking the status of the BUSY bit. The BUSY bit is a 1 during the erase cycle and becomes a 0 when the cycle is finished and the device is ready to accept other commands again. After the Erase Security Register cycle has finished the Write Enable Latch (WEL) bit in the Status Register is cleared to 0. The Security Register Lock Bits (LB[3:1]) in the Status Register-2 can be used to OTP protect the security registers. Once a lock bit is set to 1, the corresponding security register will be permanently locked, and an Erase Security Register command to that register will be ignored.


**Figure 7.33 Erase Security Registers Instruction**

### 7.5.7 Program Security Registers (42h)

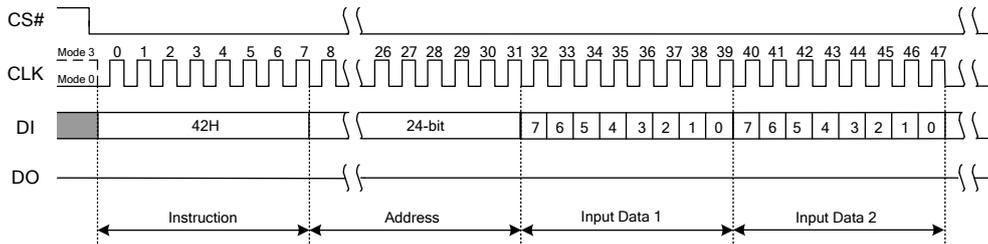
The Program Security Register command is similar to the Page Program command. It allows from one byte to 256 bytes of security register data to be programmed at previously erased (FFh) memory locations. A Write Enable command must be executed before the device will accept the Program Security Register Command (Status Register bit WEL= 1). The command is initiated by driving the CS# pin low then shifting the instruction code “42h” followed by a 24-bit address (A23-A0) and at least one data byte, into the DI pin. The CS# pin must be held low for the entire length of the command while data is being sent to the device.

Address	A23-16	A15-8	A7-0
Security Register-1	00h	10h	Byte Address
Security Register-2	00h	20h	Byte Address
Security Register-3	00h	30h	Byte Address

**Note:**

- Addresses outside the ranges in the table have undefined results.

The Program Security Register command sequence is shown in Figure 7.34. The Security Register Lock Bits (LB3:1) in the Status Register-2 can be used to OTP protect the security registers. Once a lock bit is set to 1, the corresponding security register will be permanently locked, and a Program Security Register command to that register will be ignored.


**Figure 7.34 Program Security Registers Instruction**

### 7.5.8 Read Security Registers (48h)

The Read Security Register command is similar to the Fast Read command and allows one or more data bytes to be sequentially read from one of the three security registers. The command is initiated by driving the CS# pin low and then shifting the instruction code “48h” followed by a 24-bit address (A23-A0) and eight “dummy” clocks into the DI pin. The code and address bits are latched on the rising edge of the CLK pin. After the address is received, and following the eight dummy cycles, the data byte of the addressed memory location will be shifted out on the DO pin at the falling edge of CLK with most significant bit (MSB) first. Locations with address bits A23-A16 not equal to zero, have undefined data. The byte address is automatically incremented to the next byte address after each byte of data is shifted out. Once the byte address reaches the last byte of the register (FFh), it will reset to the first byte of the register (00h) and continue to increase. The command is completed by driving CS# high. The Read Security Register command sequence is shown in Figure 7.35. If a Read Security Register command is issued while an Erase, Program, or Write cycle is in process (BUSY=1), the command is ignored and will not have any effects on the current cycle. The Read Security Register command allows clock rates from DC to a maximum of FR (see Section 8.5, AC Electrical Characteristics).

Address	A23-16	A15-8	A7-0
Security Register-1	00h	10h	Byte Address
Security Register-2	00h	20h	Byte Address
Security Register-3	00h	30h	Byte Address

**Note:**

1. Addresses outside the ranges in the table have undefined results.

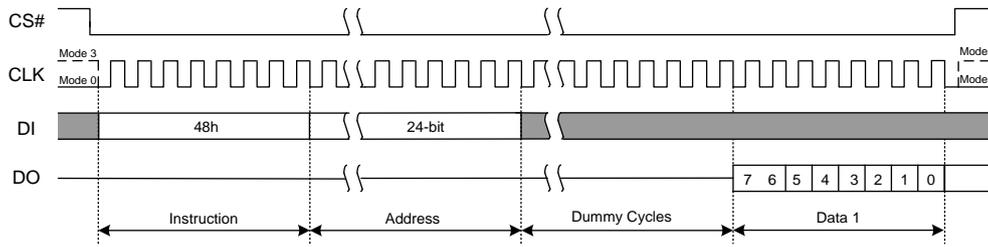


Figure 7.35 Read Security Registers Instruction

### 7.5.9 Read Manufacturer / Device ID Dual I/O (92h)

The Read Manufacturer / Device ID Dual I/O instruction is an alternative to the Read Manufacturer / Device ID instruction that provides both the JEDEC assigned manufacturer ID and the specific device ID at 2x speed.

The Read Manufacturer / Device ID Dual I/O instruction is similar to the Fast Read Dual I/O instruction. The instruction is initiated by driving the CS# pin low and shifting the instruction code "92h" followed by a 24-bit address (A23-A0) of 000000h, but with the capability to input the Address bits two bits per clock. After which, the Manufacturer ID and the Device ID are shifted out 2 bits per clock on the falling edge of CLK with most significant bits (MSB) first as shown in Figure 7.36. The Device ID values for the XM25QH32B are listed in Manufacturer and Device Identification table. The Manufacturer and Device IDs can be read continuously, alternating from one to the other. The instruction is completed by driving CS# high.

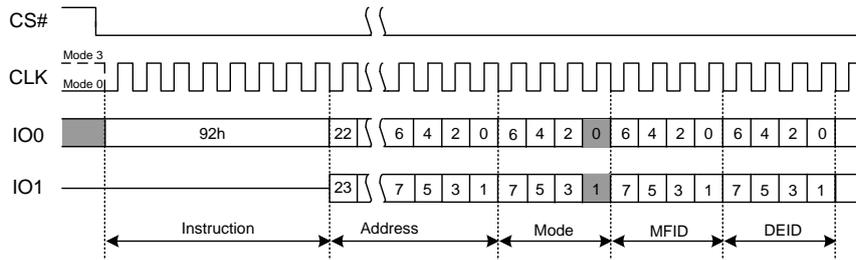


Figure 7.36 Read Manufacturer/Device ID Dual I/O Instruction

**Note:**

1. The "Continuous Read Mode" bits M7-0 must be set to Fxh to be compatible with Fast Read Dual I/O instruction.

### 7.5.10 Read Unique ID Number (4Bh)

The Read Unique ID Number instruction accesses a factory-set read-only 64-bit number which is unique to each XM25QH32B device. The ID number can be used in conjunction with user software methods to help prevent copying or cloning of a system. The Read Unique ID instruction is initiated by driving the CS# pin low and shifting the instruction code "4Bh" followed by four bytes dummy clocks. After that, the 64-bit ID is shifted out on the falling edge of CLK as shown in Figure 7.37.

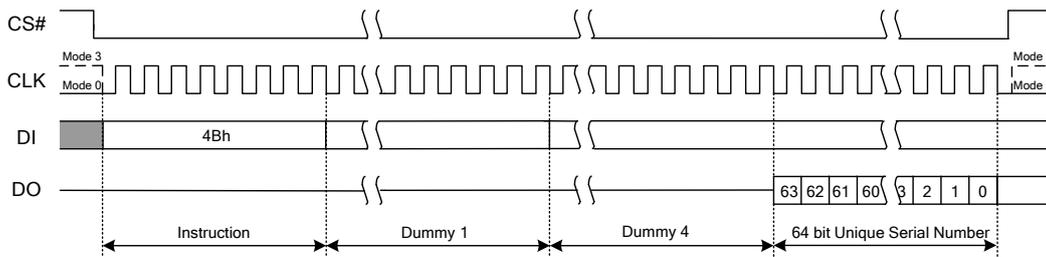


Figure 7.37 Read unique ID Number Instruction

### 7.5.11 Set Read Parameters (C0h)

In QPI mode, to accommodate a wide range of applications with different needs for either maximum read frequency or minimum data access latency, “Set Read Parameters (C0h)” instruction can be used to configure the number of dummy clocks for “Fast Read (0Bh)”, “Fast Read Quad I/O (EBh)” & “Burst Read with Wrap (0Ch)” instructions, and to configure the number of bytes of “Wrap Length” for the “Burst Read with Wrap (0Ch)” instruction.

In Standard SPI mode, the “Set Read Parameters (C0h)” instruction is not accepted. The dummy clocks for various Fast Read instructions in Standard/Dual/Quad SPI mode are independently controlled by SR3[3:0], see details in Table 6.5. The “Wrap Length” is set by W6-5 bit in the “Set Burst with Wrap (77h)” instruction. This setting will remain unchanged when the device is switched between Standard SPI mode and QPI mode.

The default “Wrap Length” after a power up or a Reset instruction is 8 bytes, the default number of dummy clocks is 2. The number of dummy clocks is only programmable for “Fast Read (0Bh)”, “Fast Read Quad I/O (EBh)” & “Burst Read with Wrap (0Ch)” instructions in the QPI mode. Whenever the device is switched from SPI mode to QPI mode, the number of dummy clocks should be set again, prior to any 0Bh, EBh or 0Ch instructions.

P5-P4	DUMMY CLOCKS	MAXIMUM READ FREQ.	MAXIMUM READ FREQ.(A[1:0]=0,0)
00	2	50MHz	50MHz
01	4	80MHz	104MHz
10	6	104MHz	104MHz
11	8	104MHz	104MHz

P1-P0	WRAP LENGTH
00	8-byte
01	16-byte
10	32-byte
11	64-byte

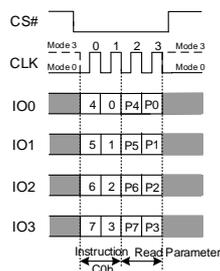


Figure 7.38 Set Read Parameters Instruction (QPI Mode only)

### 7.5.12 Burst Read with Wrap (0Ch)

The “Burst Read with Wrap (0Ch)” instruction provides an alternative way to perform the read operation with “Wrap Around” in QPI mode. The instruction is similar to the “Fast Read (0Bh)” instruction in QPI mode, except the addressing of the read operation will “Wrap Around” to the beginning boundary of the “Wrap Length” once the ending boundary is reached. The “Wrap Length” and the number of dummy clocks can be configured by the “Set Read Parameters(C0h)” instruction.

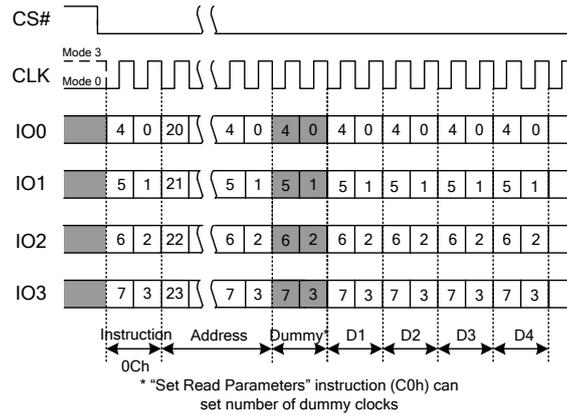


Figure 7.39 Burst Read with Wrap Instruction (QPI Mode only)

### 7.5.13 Enter QPI Mode (38h)

The XM25QH32B support both Standard/Dual/Quad Serial Peripheral Interface (SPI) and Quad Peripheral Interface (QPI). However, SPI mode and QPI mode cannot be used at the same time. "Enter QPI (38h)" instruction is the only way to switch the device from SPI mode to QPI mode.

Upon power-up, the default state of the device upon is Standard/Dual/Quad SPI mode. This provides full backward compatibility with earlier generations of XMC serial flash memories. See Instruction Set Table 7.1-7.4 for all supported SPI commands. In order to switch the device to QPI mode, the Quad Enable (QE) bit in Status Register-2 must be set to 1 first, and an "Enter QPI (38h)" instruction must be issued. If the Quad Enable (QE) bit is 0, the "Enter QPI (38h)" instruction will be ignored and the device will remain in SPI mode. See Instruction Set Table 7.5 for all the commands supported in QPI mode. When the device is switched from SPI mode to QPI mode, the existing Write Enable and Program/Erase Suspend status, and the Wrap Length setting will remain unchanged.

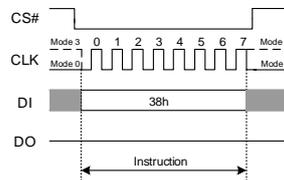


Figure 7.40 Enter QPI Instruction (SPI Mode only)

### 7.5.14 Exit QPI Mode (FFh)

In order to exit the QPI mode and return to the Standard/Dual/Quad SPI mode, an "Exit QPI (FFh)" instruction must be issued. When the device is switched from QPI mode to SPI mode, the existing Write Enable Latch (WEL) and Program/Erase Suspend status, and the Wrap Length setting will remain unchanged.

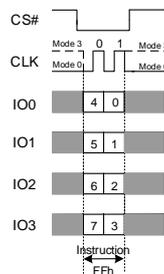


Figure 7.41 Exit QPI Instruction (QPI Mode only)

## 8. ELECTRICAL CHARACTERISTIC

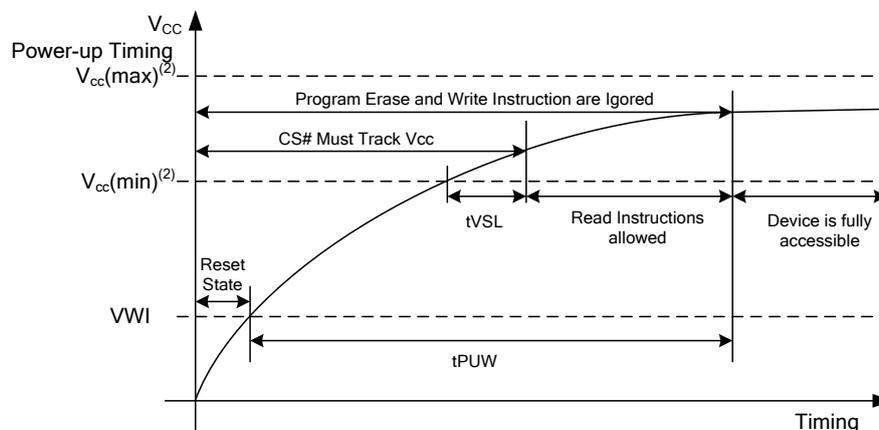


Figure 8.1 Power-up Timing

Table 8.1 Power-up Timing

PARAMETER	SYMBOL	TYPE		UNIT
		MIN	MAX	
V <sub>cc</sub> (minimum operation voltage)	V <sub>cc</sub> (min)	2.7	-	V
V <sub>cc</sub> (cut off where re-initialization is needed)	V <sub>cc</sub> (cut off)	2.1	-	V
V <sub>cc</sub> (low voltage for initialization to occur)	V <sub>cc</sub> (low)	1.0	-	V
V <sub>cc</sub> (min) to CS# Low	t <sub>VSL</sub> <sup>(1)</sup>	10	-	us
Time Delay Before Write Instruction	t <sub>PUW</sub> <sup>(1)</sup>	1	10	ms
V <sub>cc</sub> (low) time	t <sub>PD</sub>	10	-	us
Write Inhibit Threshold Voltage	V <sub>WI</sub> <sup>(1)</sup>	1	2	V

**Notes:**

- (1) The parameters are characterized only.
- (2) V<sub>cc</sub> (max.) is 3.6V and V<sub>cc</sub> (min.) is 2.7V.

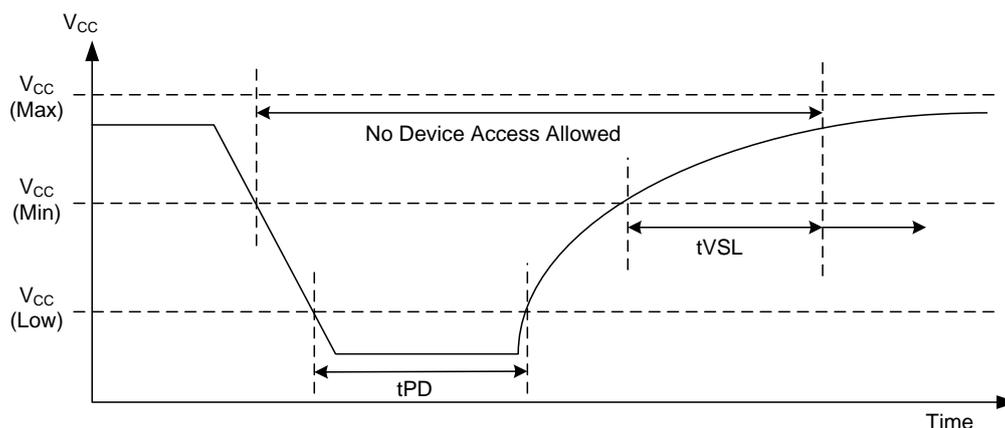


Figure 8.2 Power-Down and Voltage Drop

## 8.1. Absolute Maximum Ratings

Stresses above the values mentioned as following may cause permanent damage to the device. These values are for a stress rating only and do not imply that the device should be operated at conditions up to or above these values.

Table 8.2<sup>(1)</sup> Absolute Maximum Rating

PARAMETERS <sup>(2)</sup>	SYMBOL	CONDITIONS	RANGE	UNIT
Supply Voltage	$V_{CC}$		-0.6 to +4.0	V
Voltage applied on any pin	$V_{IO}$	Relative to Ground	-0.6 to $V_{CC}+0.4$	V
Transient Voltage on any Pin	$V_{IOT}$	<20ns Transient Relative to Ground	-2.0 to $V_{CC}+2.0$	V
Storage Temperature	$T_{STG}$		-65 to +150	°C
Lead Temperature	$T_{LEAD}$		See Note <sup>(3)</sup>	°C
Electrostatic Discharge Voltage	$V_{ESD}$	Human Body Model <sup>(4)</sup>	-2000 to +2000	V

**Notes:**

(1) Specification for XM25QH32B is preliminary. See preliminary designation at the end of this document.

(2) This device has been designed and tested for the specified operation ranges. Proper operation outside these levels is not guaranteed. Exposure to absolute maximum ratings may affect device reliability. Exposure beyond absolute maximum ratings may cause permanent damage.

(3) Compatible to JEDEC Standard J-STD-20C for small body Sn-Pb or Pb-free (Green) assembly and the European directive on restrictions on hazardous substances (RoHS) 2002/95/EU.

(4) JEDEC Std. JESD22-A114A (C1=100 pF, R1=1500 ohms, R2=500 ohms).

## 8.2. Recommended Operating Ranges

Table 8.3 Recommended Operating Ranges

PARAMETER	SYMBOL	CONDITIONS	SPEC		UNIT
			MIN	MAX	
Supply Voltage	$V_{CC}^{(1)}$	$F_R=104\text{MHz}, f_R=80\text{MHz}$	2.7	3.6	V
Ambient Temperature, Operating	$T_A$	Industrial	-40	+85	°C

**Notes:**

(1) Recommended Operating Ranges define those limits between which the functionality of the device is guaranteed.

### 8.3. DC Characteristics

**Table 8.4 DC Characteristics**

SYMBOL	PARAMETER	CONDITIONS	SPEC			UNIT
			MIN	TYP	MAX	
CIN <sup>(1)</sup>	Input Capacitance	VIN = 0V <sup>(2)</sup>			6	pF
COU <sup>(1)</sup>	Output Capacitance	VOU = 0V <sup>(2)</sup>			8	pF
ILI	Input Leakage				±2	uA
ILO	I/O Leakage				±2	uA
ICC1	Standby Current	CS# = V <sub>CC</sub> , VIN = GND or V <sub>CC</sub>		15	25	uA
ICC2	Power-down Current	CS# = V <sub>CC</sub> , VIN = GND or V <sub>CC</sub>		2	5	uA
ICC3	Current Read Data / Dual/Quad Output Read 50MHz <sup>(2)</sup>	C = 0.1 V <sub>CC</sub> / 0.9 V <sub>CC</sub> DO = Open			15	mA
ICC3	Current Read Data / Dual/Quad Output Read 80MHz <sup>(2)</sup>	C = 0.1 V <sub>CC</sub> / 0.9 V <sub>CC</sub> DO = Open			18	mA
ICC3	Current Read Data / Dual/Quad Output Read 104MHz <sup>(2)</sup>	C = 0.1 V <sub>CC</sub> / 0.9 V <sub>CC</sub> DO = Open			20	mA
ICC4	Current Page Program	CS# = V <sub>CC</sub>		8	12	mA
ICC5	Current Write Status Register	CS# = V <sub>CC</sub>		20	25	mA
ICC6	Current Sector/Block Erase	CS# = V <sub>CC</sub>		20	25	mA
ICC7	Current Chip Erase	CS# = V <sub>CC</sub>		20	25	mA
ICC8	High Performance Current			500	2500	uA
VIL	Input Low Voltage		-0.5		V <sub>CC</sub> ×0.3	V
VIH	Input High Voltage		V <sub>CC</sub> ×0.7			V
VOL	Output Low Voltage	IOL = 100 uA			0.2	V
VOH	Output High Voltage	IOH = - 100 uA	V <sub>CC</sub> - 0.2			V

**Notes:**

 (1) Tested on sample basis and specified through design and characterization data. T<sub>A</sub>=25° C, V<sub>CC</sub>=3V.

(2) All 1 Pattern.

### 8.4. AC Measurement Conditions

**Table 8.5 AC Measurement Conditions**

Symbol	PARAMETER	Min.	Max.	Unit
CL	Load Capacitance		30	pF
TR, TF	Input Rise and Fall Times		5	ns
VIN	Input Pulse Voltages	0.2V <sub>CC</sub> to 0.8V <sub>CC</sub>		V
VtIN	Input Timing Reference Voltages	0.3V <sub>CC</sub> to 0.7V <sub>CC</sub>		V
VtON	Output Timing Reference Voltages	0.5 V <sub>CC</sub> to 0.5 V <sub>CC</sub>		V


**Figure 8.3 AC Measurement I/O Waveform**

**8.5. AC Electrical Characteristics**

Table 8.6 AC Electrical Characteristics

SYMBOL	ALT	Parameter	SPEC			UNIT
			MIN	TYP	MAX	
$F_R$	$f_c$	Clock frequency for all instructions, except Read Data (03h) <sup>(5)</sup> 2.7V-3.6V $V_{CC}$	D.C.		104 <sup>(6)</sup>	MHz
$f_R$		Clock frequency for Read Data instruction (03h) 2.7V-3.6V $V_{CC}$	D.C.		80	MHz
$t_{CLH}, t_{CLL}$ <sup>(1)</sup>		Clock High, Low Time for all instructions except Read Data (03h)	4			ns
$t_{CRLH}, t_{CRLl}$ <sup>(1)</sup>		Clock High, Low Time for Read Data (03h) instruction	6			ns
$t_{CLCH}$ <sup>(2)</sup>		Clock Rise Time peak to peak	0.1			V/ns
$t_{CHCL}$ <sup>(2)</sup>		Clock Fall Time peak to peak	0.1			V/ns
$t_{SLCH}$	$t_{CSS}$	CS# Active Setup Time relative to CLK	5			ns
$t_{CHSL}$		CS# Not Active Hold Time relative to CLK	5			ns
$t_{DVCH}$	$t_{DSU}$	Data In Setup Time	2			ns
$t_{CHDX}$	$t_{DH}$	Data In Hold Time	5			ns
$t_{CHSH}$		CS# Active Hold Time relative to CLK	5			ns
$t_{SHCH}$		CS# Not Active Setup Time relative to CLK	5			ns
$t_{SHSL}$	$t_{CSH}$	CS# Deselect Time (SPI/QPI)	50/100			ns
$t_{SHOZ}$ <sup>(2)</sup>	$t_{DIS}$	Output Disable Time			7	ns
$t_{CLQV}$	$t_V$	Clock Low to Output Valid 2.7V- 3.6V			7	ns
$t_{CLQX}$	$t_{HO}$	Output Hold Time	2			ns
$t_{HLCH}$		HOLD# Active Setup Time relative to CLK	5			ns
$t_{CHHH}$		HOLD# Active Hold Time relative to CLK	5			ns
$t_{HHCH}$		HOLD# Not Active Setup Time relative to CLK	5			ns
$t_{CHHL}$		HOLD# Not Active Hold Time relative to CLK	5			ns
$t_{HHQX}$	$t_{LZ}$ <sup>(2)</sup>	HOLD# to Output Low-Z			7	ns
$t_{HLQZ}$	$t_{HZ}$ <sup>(2)</sup>	HOLD# to Output High-Z			12	ns
$t_{WHSL}$ <sup>(3)</sup>		Write Protect Setup Time Before CS# Low	20			ns
$t_{SHWL}$ <sup>(3)</sup>		Write Protect Hold Time After CS# High	100			ns
$t_{DP}$ <sup>(2)</sup>		CS# High to Power-down Mode			3	us
$t_{RES1}$ <sup>(2)</sup>		CS# High to Standby Mode without Electronic Signature Read			8	us
$t_{RES2}$ <sup>(2)</sup>		CS# High to Standby Mode with Electronic Signature Read			6	us
$t_{SUS}$ <sup>(2)</sup>		CS# High to next Command after Suspend			20	us
$t_W$		Write Status Register Time		10	100	ms
$t_{PP}$		Page Program Time		0.5	3	ms
$t_{SE}$		Sector Erase Time (4KB)		50	700/1000 <sup>(7)</sup>	ms
$t_{BE1}$		Block Erase Time (32KB)		0.15	0.8	s
$t_{BE2}$		Block Erase Time (64KB)		0.3	2/2.5 <sup>(8)</sup>	s
$t_{CE}$		Chip Erase Time		10	50	s
$t_{RCH}$ <sup>(2)</sup>		End of Reset Instruction to CE# High	40			ns
$t_{RST}$ <sup>(2)(4)</sup>		CE# High to next Instruction after Reset	10			us

**Notes:**

- (1) Clock high + Clock low must be less than or equal to  $1/f_c$ .
- (2) Value guaranteed by design and/or characterization, not 100% tested in production.
- (3) Only applicable as a constraint for a Write Status Register instruction when Sector Protect Bit is set to 1.4. For multiple bytes after first byte within a page,  $t_{BPN} = t_{BP1} + t_{BP2} * N$  (typical) and  $t_{BPN} = t_{BP1} + t_{BP2} * N$  (max), where N = number of bytes programmed.
- (4) It's possible to reset the device with shorter tRESET (as short as a few hundred ns), a 1us minimum is recommended to ensure reliable operation.
- (5) It's recommended to use low frequency (i.e. below 66MHz) for the following commands: QPI Read SR(05h, 35h, 15h) and QPI Read ID(90h, 9Fh).
- (6) If QPI mode read speed, it's recommended to turn on HFM to reach read frequency 104MHz, if not turn on HFM, QPI mode read speed only can reach 40MHz.
- (7) Max Value 4KB  $t_{SE}$  with <50K cycles is 700ms and >50K & <100k cycles is 1000ms.
- (8) Max Value 64KB  $t_{BE}$  with <50K cycles is 2s and >50K & <100k cycles is 2.5s.

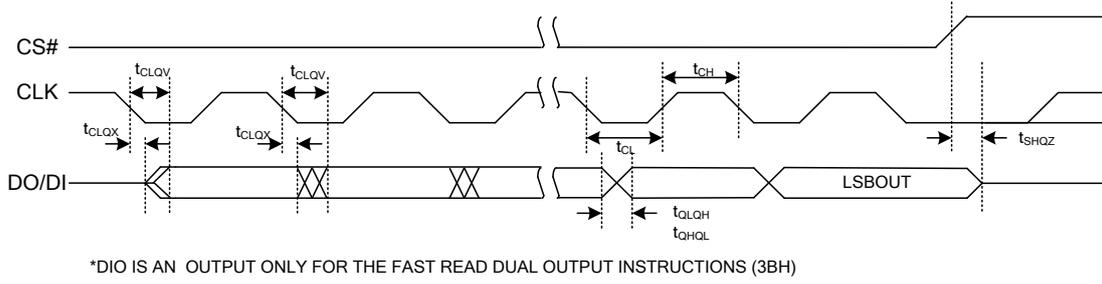


Figure 8.4 Serial Output Timing

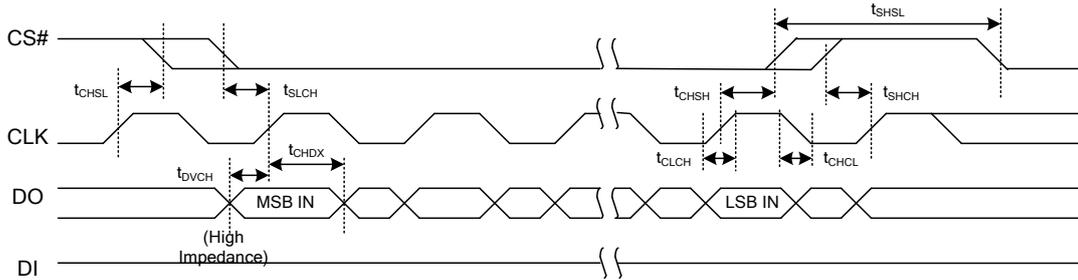


Figure 8.5 Input Timing

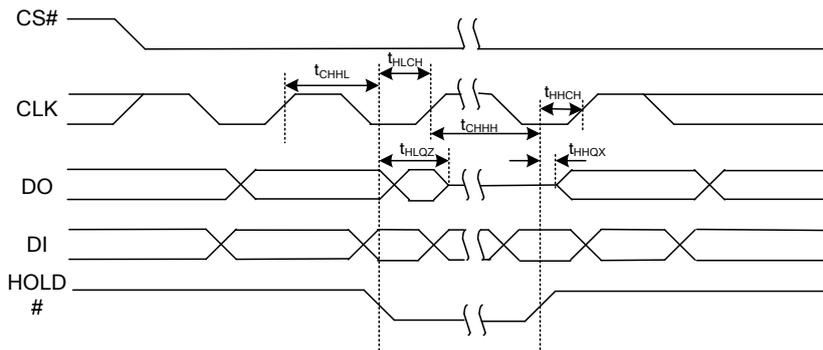


Figure 8.6 Hold Timing

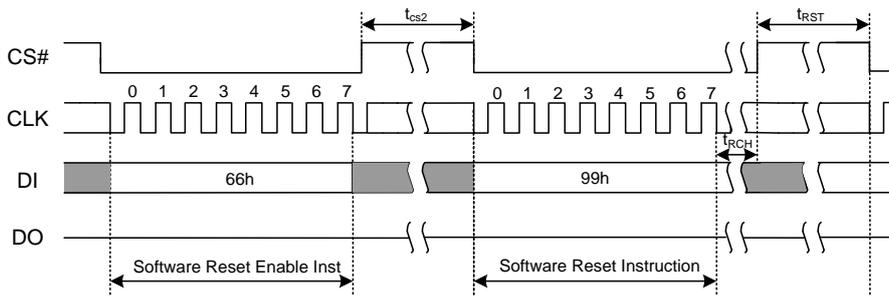
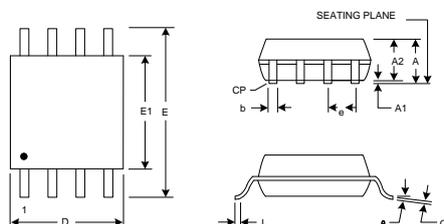


Figure 8.7 Software Reset Input Timing

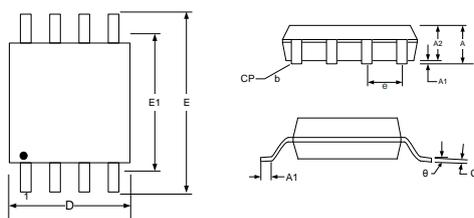
## 9. PACKAGE MECHANICAL

### 9.1. SOP 208mil 8L

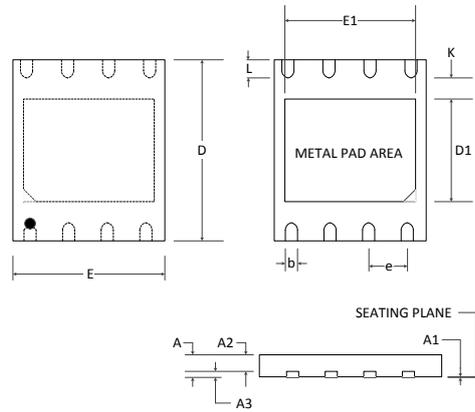


SYMBOL	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	1.75	2.16	0.069	0.085
A1	0.05	0.25	0.002	0.010
A2	1.70	1.91	0.067	0.075
b	0.35	0.48	0.014	0.019
c	0.19	0.25	0.007	0.010
D <sup>(3)</sup>	5.18	5.38	0.204	0.212
E	7.70	8.10	0.303	0.319
E1 <sup>(3)</sup>	5.18	5.38	0.204	0.212
e <sup>(2)</sup>	1.27 BSC		0.050 BSC	
L	0.50	0.80	0.020	0.031
θ	0°	8°	0°	8°
y	---	0.10	---	0.004

### 9.2. SOP 150mil 8L



SYMBOL	MILLIMETERS			INCHES		
	MIN	TYP	MAX	MIN	TYP	MAX
A	1.47	1.60	1.72	0.058	0.063	0.068
A1	0.10	---	0.24	0.004	---	0.009
A2	---	1.45	---	---	0.057	---
b	0.33	0.41	0.50	0.013	0.016	0.020
C	0.19	0.20	0.25	0.013	0.016	0.020
D(3)	4.80	4.85	4.95	0.0075	0.008	0.0098
E	5.80	6.00	6.19	0.228	0.236	0.244
E1(3)	3.80	3.90	4.00	0.150	0.154	0.157
e(2)	1.27BSC			0.050BSC		
L	0.40	0.71	1.27	0.015	0.028	0.050
θ	0°	---	8°	0°	---	8°
CP	---	---	0.10	---	---	0.004

**9.3 WSON 5x6 8L**


SYMBOL	MILLIMETERS			INCHES		
	MIN	NOM	MAX	MIN	NOM	MAX
A	0.70	0.75	0.80	0.0276	0.0295	0.0315
A1	0.00	0.02	0.05	0.0000	0.0008	0.0019
A2		0.55			0.0126	
A3	0.19	0.20	0.25	0.0075	0.0080	0.0098
b	0.36	0.40	0.48	0.0138	0.0157	0.0190
D <sup>(1)</sup>	5.90	6.00	6.10	0.2320	0.2360	0.2400
D1	3.30	3.40	3.50	0.1299	0.1338	0.1377
E	4.90	5.00	5.10	0.1930	0.1970	0.2010
E1 <sup>(1)</sup>	4.20	4.30	4.40	0.1653	0.1692	0.1732
e <sup>(2)</sup>		1.27BSC			0.5000 BSC	
K	0.20			0.0080		
L	0.50	0.60	0.75	0.0197	0.0238	0.0295

## REVISION LIST

Version No.	Description	Date
A	Initial Release	2016/08/22
B	Change Table 6.5 and contents	2016/08/30
C	Change content 4.7, content 7.2.6, Table 6.2, Table 8.6	2016/09/14
D	Change Table 8.1	2016/11/29
E	Change Table 6.5	2016/12/12
F	Change Features in page 3, Table 8.4 and Table 8.6	2017/01/20
G	Change Features in page 3 and Table 8.6	2017/05/05
H	Change SFDP Data in Table 5.3 and Table 5.4	2017/05/26
I	Change 6.2.12 Output Driver Strength ; Change Table 8.6	2017/08/09
J	Change Table 6.2	2017/10/17
K	Change SFDP Table	2017/11/08
L	Update Ordering Information	2018/02/28
M	1. Add package type SOP 150mil 8L in Package Options and Package Mechanical 2. Update the package name of SOP, WSON packages 3. Update the Package Type of Ordering Information 4. Add note2 for write SR polling bit in P21 5. Add note for Quad Input Page Program (32h) in P38 6. Change the MAX value of ICC8 (from 800uA to 2500uA) in Table 8.4 DC Characteristics in P60 7. Change Note(2) "Checker Board Pattern" to "All 1 Pattern" for Table 8.4 DC Characteristics in P60 8. Change the MAX value of tSE (from 300ms to 700/1000ms) in Table 8.6 AC Electrical Characteristics in P61 9. Change the MAX value of tBE2 (from 2s to 2/2.5s) in Table 8.6 AC Electrical Characteristics in P61 10. Add note6, note7, note8 for Table 8.6 AC Electrical Characteristics in P61 11. Change HFQ to HFM	2018/07/17